



MEASUREMENT REPORT

FCC Part 22 & 27 LTE

Applicant Name:

Samsung Electronics, Co. Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do 443-742, Korea

Date of Testing:

Aug. 31 - Sep. 5, 2013

Test Site/Location:

PCTEST Lab., Columbia, MD, USA

Test Report Serial No.:

0Y1308271675.A3L

FCC ID :

A3LSCHR890

APPLICANT:

SAMSUNG ELECTRONICS, CO. LTD.

FCC Classification:

PCS Licensed Transmitter Held to Ear (PCE)

FCC Rule Part(s):

§2; §22; §27

EUT Type:

Portable Handset

Model(s):

SCH-R890

Test Device Serial No.:

identical prototype [S/N: 57,56]

Mode	Tx Frequency (MHz)	Emission Designator	Modulation	ERP/EIRP	
				Max. Power (W)	Max. Power (dBm)
LTE Band 12	701.5 - 713.5	4M50G7W	QPSK	0.034	15.31
LTE Band 12	701.5 - 713.5	4M51W7W	16QAM	0.027	14.31
LTE Band 12	704 - 711	8M98G7W	QPSK	0.037	15.70
LTE Band 12	704 - 711	8M97W7W	16QAM	0.030	14.77
LTE Band 5	826.5 - 846.5	4M50G7W	QPSK	0.014	11.48
LTE Band 5	826.5 - 846.5	4M51W7W	16QAM	0.011	10.48
LTE Band 5	829 - 844	8M99G7W	QPSK	0.010	10.02
LTE Band 5	829 - 844	9M00W7W	16QAM	0.009	9.63

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested. I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Randy Ortanez
President

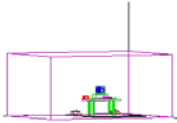


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Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 1 of 47

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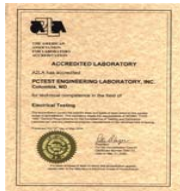


§2.1033 General Information

APPLICANT: Samsung Electronics, Co. Ltd.
APPLICANT ADDRESS: 129, Samsung-ro, Maetan dong,
 Yeongtong-gu, Suwon-si, Gyeonggi-do 443-742, Korea
TEST SITE: PCTEST ENGINEERING LABORATORY, INC.
TEST SITE ADDRESS: 6660-B Dobbin Road, Columbia, MD 21045 USA
FCC RULE PART(S): §2; §22; §27
BASE MODEL: SCH-R890
FCC ID: A3LSCHR890
FCC CLASSIFICATION: PCS Licensed Transmitter Held to Ear (PCE)
FREQUENCY TOLERANCE: $\pm 0.00025\%$ (2.5 ppm)
Test Device Serial No.: 57,56 ☐ Production ☒ Pre-Production ☐ Engineering
DATE(S) OF TEST: Aug. 31 - Sep. 5, 2013
TEST REPORT S/N: 0Y1308271675.A3L

Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.



- PCTEST facility is an FCC registered (PCTEST Reg. No. 90864) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451A-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451A-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

1.2 Testing Facility

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Intern't'l (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility in New Concept Business Park, Guilford Industrial Park, Columbia, Maryland. The site address is 6660-B Dobbin Road, Columbia, MD 21045. The test site is one of the highest points in the Columbia area with an elevation of 390 feet above mean sea level. The site coordinates are 39° 11'15" N latitude and 76° 49'38" W longitude. The facility is 1.5 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. There are no FM or TV transmitters within 15 miles of the site. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2009 on January 10, 2012.

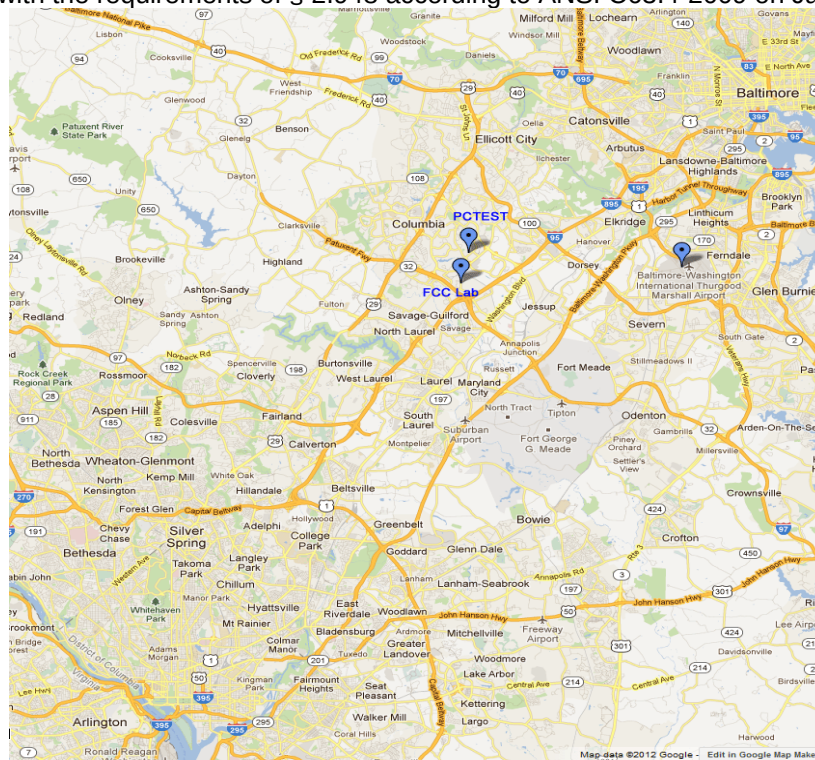


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSCHR890**. The test data contained in this report pertains only to the emissions due to the EUT's LTE function.

2.2 Device Capabilities

This device contains the following capabilities:

850/1900 CDMA/EvDO Rev0/A (BC0, BC1), Band 12 (5 and 10 MHz BW), 17 (5 and 10MHz BW) and 5 (5 and 10MHz BW) LTE, 802.11a/b/g/n WLAN (DTS/Nil), Bluetooth (1x,EDR, LE), NFC

Note:

This device supports LTE band 12 and LTE band 17. However, LTE band 12 frequencies cover more than the entire range of Band 17. Therefore, only Band 12 test data were reported in the test report.

2.3 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

2.4 Labeling Requirements

Per 2.925

The FCC identifier shall be permanently affixed to the equipment and shall be readily visible to the purchaser at the time of purchase.

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3.0 DESCRIPTION OF TESTS

3.1 Measurement Procedure

The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI/TIA-603-C-2004) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168) were used in the measurement of the **Samsung Portable Handset FCC ID: A3LSCHR890**.

3.2 Block A Frequency Range

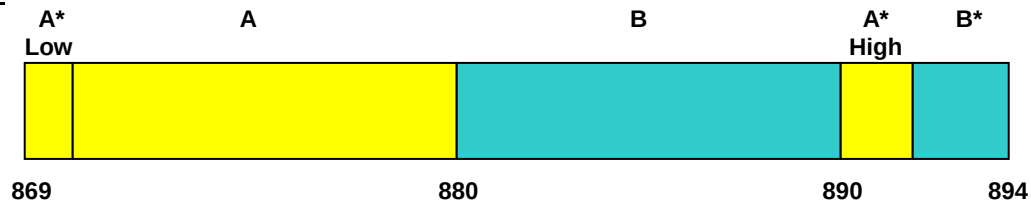
§27.5(c)

698-746 MHz band. The following frequencies are available for licensing pursuant to this part in the 698-746 MHz band: (1) Three paired channel blocks of 12 megahertz each are available for assignment as follows:

Block A: 698-704 MHz and 728-734 MHz;
Block B: 704-710 MHz and 734-740 MHz; and
Block C: 710-716 MHz and 740-746 MHz.

3.3 Cellular - Base Frequency Blocks

§24.905

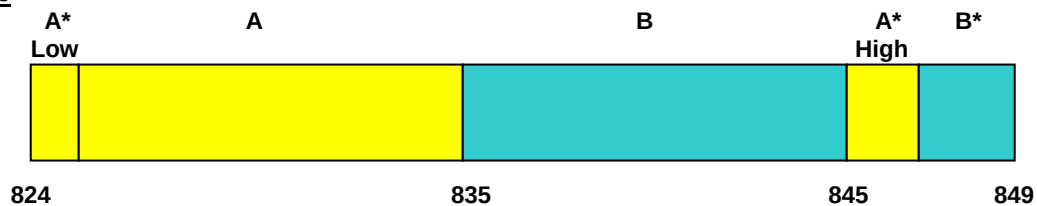


BLOCK 1: 869 – 880 MHz (A* Low + A)
BLOCK 2: 880 – 890 MHz (B)

BLOCK 3: 890 – 891.5 MHz (A* High)
BLOCK 4: 891.5 – 894 MHz (B*)

3.4 Cellular - Mobile Frequency Blocks

§24.905



BLOCK 1: 824 – 835 MHz (A* Low + A)
BLOCK 2: 835 – 845 MHz (B)

BLOCK 3: 845 – 846.5 MHz (A* High)
BLOCK 4: 846.5 – 849 MHz (B*)

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3.5 Occupied Bandwidth

§2.1049 RSS-Gen(4.6.1)

The implementation of this test is performed by the spectrum analyzer's occupied bandwidth function. The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured.

3.6 Spurious and Harmonic Emissions at Antenna Terminal

§2.1051 §22.917(a)(b) §27.53(g) RSS-132(4.5.1)

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. On any frequency outside a licensee's frequency block, the power of any emission shall be attenuated below the transmitter power (P) by at least $43 + 10 \log(P)$ dB. Compliance with these provisions is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for Cell band, 698–746 MHz band,. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed for. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

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3.7 SVLTE

§2.1053 §22.917(a) §24.238(a) §27.53(g) §27.53(h) RSS-132(4.5.1) RSS-133(6.5.1) RSS-139(6.5.1)

This device is capable of operating in SVLTE mode in the following cases:

No.	Capable Transmit Configurations	Head	Body-worn Accessory	Hot Spot	Note
		IEEE 1528, Supp C	Supplement C	FCC KDB 941225 D08 edges/sides	
1	1X CDMA 850 Voice + LTE 700 MHz LTE Band12 Data	✓	✓	N/A	SVLTE
2	1X CDMA 1900 Voice + LTE 700 MHz LTE Band12 Data	✓	✓	N/A	SVLTE
3	1X CDMA 850 Voice + LTE 700 MHz LTE Band17 Data	✓	✓	N/A	SVLTE
4	1X CDMA 1900 Voice + LTE 700 MHz LTE Band17 Data	✓	✓	N/A	SVLTE
5	1X CDMA 850 Voice + LTE 850 MHz Data	✓	✓	N/A	SVLTE
6	1X CDMA 1900 Voice + LTE 850 MHz Data	✓	✓	N/A	SVLTE

Table 3-1. SVLTE Transmit Configurations

All modes of SVLTE operation were investigated. It was determined that this device did not produce any intermodulation products that were within 25dB of the spurious emission limit so the emissions are not reported herein.

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3.8 Radiated Power and Radiated Spurious Emissions

§2.1053 §22.913(a.2) §22.917(a) §27.50(c.10) §27.53(g) RSS-132(4.4) RSS-132(4.5.1)

Radiated spurious emissions are investigated indoors in a semi-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-C-2004. The measurement area is situated on an 18 meter x 20 meter galvanized 1/2" hardware cloth as the conducting ground plane. This material is sewn together in sections 4 feet wide and 60 feet long. A total of eighteen sections are required to cover the entire measurement area. Sections are laid across the width of the pad, overlapped 1" and sewn and soldered together at intervals of 3" (7.6 cm.) The terrain of the test site is reasonably flat and level. Power and cable to the test site are buried 18" deep into the ground outside the perimeter of the site. An all-weather non-metallic housing is situated on a 2 x 3 meter area adjacent to the measurement area to house the test equipment. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized. The level of the maximized emission is recorded with the spectrum analyzer using a peak detector with RBW = 1MHz, VBW = 3MHz for emissions greater than 1GHz. For emissions below 1GHz, the spectrum analyzer is set to RBW = 100kHz and VBW = 300kHz.

A half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_d \text{ [dBm]} = P_g \text{ [dBm]} - \text{cable loss [dB]} + \text{antenna gain [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_g \text{ [dBm]} - \text{cable loss [dB]}$.

The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power [Watts]})$ specified in 22.917(a), 24.238(a), and 27.53(g)(h).

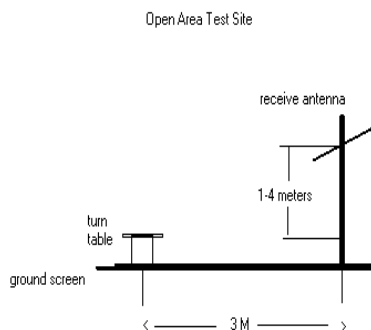


Figure 3-1. Diagram of 3-meter Test Range

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3.9 Frequency Stability / Temperature Variation

§2.1055 §22.863 §22.905 §27.5(c) §27.54 RSS-132(4.3)

The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block for Part 27. The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency for Part 22.

Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for one minute before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A sufficient stabilization period at each temperature shall be used prior to each frequency requirement.

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4.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST).

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	3/29/2013	Annual	3/29/2014	N/A
-	RE2	Radiated Emissions Cable Set (VHF/UHF)	3/29/2013	Annual	3/29/2014	N/A
-	LTx2	Licensed Transmitter Cable Set	1/17/2013	Annual	1/17/2014	N/A
Agilent	8449B	(1-26.5GHz) Pre-Amplifier	4/17/2013	Annual	4/17/2014	3008A00985
Agilent	8648D	(9kHz-4GHz) Signal Generator	10/10/2012	Annual	10/10/2013	3613A00315
Agilent	N9020A	MXA Signal Analyzer	10/9/2012	Annual	10/9/2013	US46470561
Agilent	N9038A	MXE EMI Receiver	12/8/2012	Annual	12/8/2013	MY51210133
Agilent	N9030A	PXA Signal Analyzer (44GHz)	1/11/2013	Annual	1/11/2014	MY52350166
Agilent	8447D	Broadband Amplifier	5/31/2013	Annual	5/31/2014	1937A03348
Anritsu	MA2411B	Pulse Sensor	9/19/2012	Annual	9/19/2013	1027293
Anritsu	ML2495A	Power Meter	10/11/2012	Annual	10/11/2013	1039008
Emco	6502	Active Loop Antenna (10k - 30 MHz)	5/31/2012	Biennial	5/31/2014	267
Mini-Circuits	VHF-1300+	High Pass Filter	1/21/2013	Annual	1/21/2014	30716
Mini-Circuits	VHF-3100+	High Pass Filter	1/21/2013	Annual	1/21/2014	31144
Rohde & Schwarz	CMW500	LTE Radio Communication Tester	10/7/2011	Biennial	10/7/2013	103962
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Tx	10/3/2011	Biennial	10/3/2013	91052522TX
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	10/3/2011	Biennial	10/3/2013	91052523RX
Schwarzbeck	VULB-9161SE	Trilog Super Broadband Test Antenna	11/8/2011	Biennial	11/8/2013	9161-4075
Seekonk	NC-100	Torque Wrench (8" lb)	3/5/2012	Triennial	3/5/2015	N/A
Sunol	DRH-118	Horn Antenna (1 - 18GHz)	6/19/2013	Biennial	6/19/2015	A050307
Sunol	DRH-118	Horn Antenna (1-18 GHz)	6/19/2013	Biennial	6/19/2015	A042511

Table 4-1. Test Equipment

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5.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Amplitude/Angle Modulated

16QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Combination (Audio/Data)

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

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6.0 TEST RESULTS

6.1 Summary

Company Name: Samsung Electronics, Co. Ltd.
 FCC ID: A3LSCHR890
 FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)
 Mode(s): LTE

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Result	Reference
TRANSMITTER MODE (TX)					
2.1049	Occupied Bandwidth	N/A	CONDUCTED	PASS	Section 7.0, 8.0
2.1051 22.917(a) 27.53(g)	Band Edge / Conducted Spurious Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ at Band Edge and for all out-of-band emissions		PASS	Section 7.0, 8.0
2.1046	Transmitter Conducted Output Power	N/A		PASS	See RF Exposure Report
22.913(a.2)	Effective Radiated Power (Band 5)	< 7 Watts max. ERP	RADIATED	PASS	Section 6.2
27.50(c.10)	Effective Radiated Power (Band 12)	< 3 Watts max. ERP		PASS	Section 6.2
2.1053 22.917(a) 27.53(g)	Undesirable Emissions	$> 43 + 10\log_{10}(P[\text{Watts}])$ for all out-of-band emissions		PASS	Section 6.3, 6.4
2.1055. 22.355 27.54	Frequency Stability	< 2.5 ppm (Part 22) and fundamental emissions stay within authorized frequency block (Part 27)		PASS	Section 6.5, 6.6

Table 6-1. Summary of Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots shown in Section 7.0 8.0 were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.

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6.2 Effective Radiated Power (ERP)

§22.913(a.2) §27.50(c.10) RSS-132(4.4)

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Battery	RB Size/Offset	Substitute Level [dBm]	Antenna Gain [dBd]	Pol [H/V]	ERP [dBm]	ERP [Watts]	Margin [dB]
701.50	5	QPSK	Standard	1/24	14.03	-0.95	V	13.08	0.020	-21.69
707.50	5	QPSK	Standard	1/24	14.75	-0.95	V	13.80	0.024	-20.97
713.50	5	QPSK	Standard	1/24	16.26	-0.95	V	15.31	0.034	-19.46
701.50	5	16-QAM	Standard	1/24	13.05	-0.95	V	12.10	0.016	-22.67
707.50	5	16-QAM	Standard	1/24	13.45	-0.95	V	12.50	0.018	-22.27
713.50	5	16-QAM	Standard	1/24	15.26	-0.95	V	14.31	0.027	-20.46
704.00	10	QPSK	Standard	1/49	13.10	-0.95	V	12.15	0.016	-22.62
707.50	10	QPSK	Standard	1/49	15.11	-0.95	V	14.16	0.026	-20.61
711.00	10	QPSK	Standard	1/49	16.65	-0.95	V	15.70	0.037	-19.07
704.00	10	16-QAM	Standard	1/49	12.24	-0.95	V	11.29	0.013	-23.48
707.50	10	16-QAM	Standard	1/49	14.17	-0.95	V	13.22	0.021	-21.55
711.00	10	16-QAM	Standard	1/49	15.72	-0.95	V	14.77	0.030	-20.00

Table 6-2. ERP Data (Band 12)

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Battery	RB Size/Offset	Substitute Level [dBm]	Antenna Gain [dBd]	Pol [H/V]	ERP [dBm]	ERP [Watts]	Margin [dB]
826.50	5	QPSK	Standard	1/24	12.63	-1.15	V	11.48	0.014	-26.97
836.50	5	QPSK	Standard	1/24	10.17	-1.15	V	9.02	0.008	-29.43
846.50	5	QPSK	Standard	1/0	11.09	-1.15	V	9.94	0.010	-28.51
826.50	5	16-QAM	Standard	1/24	11.63	-1.15	V	10.48	0.011	-27.97
836.50	5	16-QAM	Standard	1/24	8.95	-1.15	V	7.80	0.006	-30.65
846.50	5	16-QAM	Standard	1/0	9.98	-1.15	V	8.83	0.008	-29.62
829.00	10	QPSK	Standard	1/0	11.17	-1.15	V	10.02	0.010	-28.43
836.50	10	QPSK	Standard	1/49	11.15	-1.15	V	10.00	0.010	-28.45
844.00	10	QPSK	Standard	1/0	10.67	-1.15	V	9.52	0.009	-28.93
829.00	10	16-QAM	Standard	1/0	10.78	-1.15	V	9.63	0.009	-28.82
836.50	10	16-QAM	Standard	1/49	10.02	-1.15	V	8.87	0.008	-29.58
844.00	10	16-QAM	Standard	1/0	9.24	-1.15	V	8.09	0.006	-30.36

Table 6-3. ERP Data (Band 5)

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

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6.3 Band 12 Radiated Spurious Emissions

§2.1053 §27.53(g)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 704.00 MHz
 MEASURED OUTPUT POWER: 12.15 dBm = 0.016 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 10 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 25.15 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBd)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
1408.00	-55.63	8.23	-47.40	H	59.55
2112.00	-57.02	9.06	-47.96	H	60.12
2816.00	-87.14	10.23	-76.91	H	89.06
3520.00	-83.52	9.78	-73.74	H	85.89
4224.00	-82.06	10.34	-71.71	H	83.86

Table 6-4. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

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Band 12 Radiated Spurious Measurements (continued)

§2.1053 §27.53(g)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 707.50 MHz
 MEASURED OUTPUT POWER: 14.16 dBm = 0.026 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 10 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10}(W) =$ 27.16 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBd)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
1415.00	-54.47	8.25	-46.22	H	60.38
2122.50	-56.62	9.05	-47.57	H	61.73
2830.00	-87.08	10.24	-76.84	H	91.00
3537.50	-83.62	9.85	-73.77	H	87.93
4245.00	-82.17	10.42	-71.75	H	85.91

Table 6-5. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

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Band 12 Radiated Spurious Measurements (continued)

§2.1053 §27.53(g)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 711.00 MHz
 MEASURED OUTPUT POWER: 15.70 dBm = 0.037 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 10 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 28.70 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBd)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
1422.00	-54.16	8.27	-45.90	H	61.60
2133.00	-55.34	9.04	-46.30	H	62.00
2844.00	-87.01	10.24	-76.77	H	92.47
3555.00	-83.71	9.92	-73.78	H	89.49
4266.00	-82.25	10.50	-71.75	H	87.45

Table 6-6. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

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6.4 Band 5 Radiated Spurious Emissions

§2.1053 §22.917(a) RSS-132(4.5.1)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 826.50 MHz
 MEASURED OUTPUT POWER: 11.48 dBm = 0.014 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 5 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 24.48 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBd)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
1653.00	-55.74	8.43	-47.31	H	58.79
2479.50	-55.06	8.72	-46.35	H	57.83
3306.00	-83.13	9.18	-73.94	H	85.42
4132.50	-81.40	9.90	-71.50	H	82.98
4959.00	-81.14	11.20	-69.94	H	81.42

Table 6-7. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

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Band 5 Radiated Spurious Measurements (continued)

§2.1053 §22.917(a) RSS-132(4.5.1)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 836.50 MHz
 MEASURED OUTPUT POWER: 9.02 dBm = 0.008 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 5 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10}(W) =$ 22.02 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBd)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
1673.00	-58.14	8.34	-49.80	H	58.82
2509.50	-53.41	8.73	-44.68	H	53.70
3346.00	-83.26	9.31	-73.95	H	82.97
4182.50	-81.81	10.14	-71.67	H	80.69
5019.00	-80.77	11.13	-69.64	H	78.66

Table 6-8. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

FCC ID: A3LSCHR890		FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
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Band 5 Radiated Spurious Measurements (continued)

§2.1053 §22.917(a) RSS-132(4.5.1)

Field Strength of SPURIOUS Radiation

OPERATING FREQUENCY: 846.50 MHz
 MEASURED OUTPUT POWER: 9.94 dBm = 0.010 W
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 5 MHz
 DISTANCE: 3 meters
 LIMIT: $43 + 10 \log_{10} (W) =$ 22.94 dBc

FREQUENCY (MHz)	LEVEL @ ANTENNA TERMINALS (dBm)	SUBSTITUTE ANTENNA GAIN (dBd)	SPURIOUS EMISSION LEVEL (dBm)	POL (H/V)	(dBc)
1693.00	-57.69	8.24	-49.45	H	59.39
2539.50	-56.28	8.81	-47.47	H	57.41
3386.00	-83.39	9.43	-73.96	H	83.90
4232.50	-82.07	10.33	-71.74	H	81.68
5079.00	-80.28	11.04	-69.24	H	79.18

Table 6-9. Radiated Spurious Data

NOTES:

1. This device was tested under all bandwidths, and RB configurations, and modulations. This device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported in the Table above.
2. This unit was tested with its standard battery.
3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The "H" positioning is defined with the EUT lying flat on the test surface, the "H2" positioning is defined with the EUT standing up on its side, and the "V" positioning is defined with the EUT standing upright. The worst case test configuration was found with the EUT in the V positioning. The data reported in the table above was measured in this test setup.

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6.5 Band 12 Frequency Stability Measurements

\$2.1055 \$22.355 \$27.54

OPERATING FREQUENCY: 707,500,000 Hz

CHANNEL: 23790

REFERENCE VOLTAGE: 3.8 VDC

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	707,499,981	-19	-0.0000027
100 %		- 30	707,499,997	-3	-0.0000004
100 %		- 20	707,499,999	-1	-0.0000001
100 %		- 10	707,499,983	-17	-0.0000023
100 %		0	707,499,998	-2	-0.0000004
100 %		+ 10	707,499,990	-10	-0.0000014
100 %		+ 20	707,499,989	-11	-0.0000016
100 %		+ 30	707,499,998	-2	-0.0000003
100 %		+ 40	707,499,990	-10	-0.0000013
100 %		+ 50	707,499,997	-3	-0.0000004
115 %	4.37	+ 20	707,499,994	-6	-0.0000009
BATT. ENDPOINT	3.40	+ 20	707,499,981	-19	-0.0000027

Table 6-10. Frequency Stability Data (Band 12)

Band 12 Frequency Stability Measurements (Cont'd)

§2.1055 §22.355 §27.54

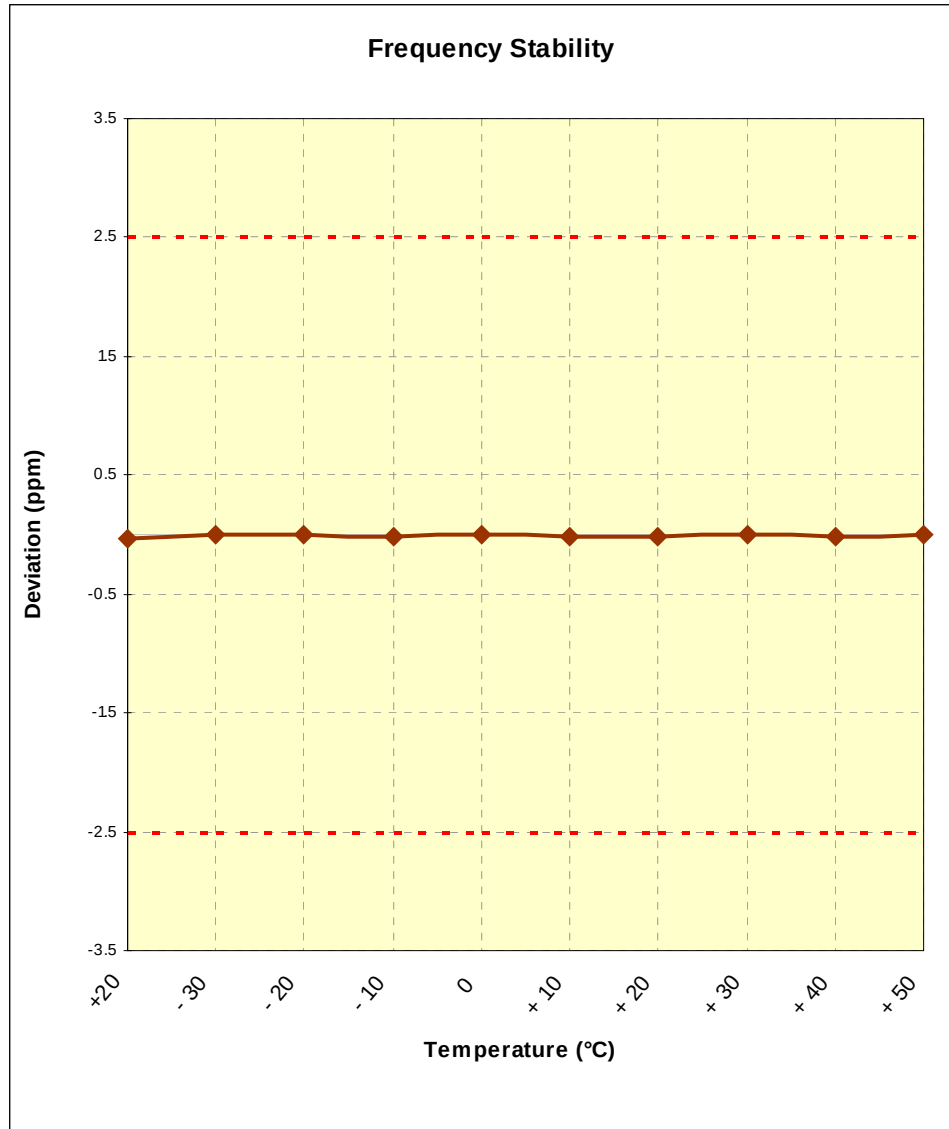


Figure 6-1. Frequency Stability Graph (Band 12)

FCC ID: A3LSCHR890		FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
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6.6 Band 5 Frequency Stability Measurements

§2.1055 §22.355 RSS-132(4.3)

OPERATING FREQUENCY: 836,500,000 Hz

CHANNEL: 20525

REFERENCE VOLTAGE: 3.8 VDC

DEVIATION LIMIT: ± 0.00025 % or 2.5 ppm

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	836,499,987	-13	-0.0000015
100 %		- 30	836,499,998	-2	-0.0000002
100 %		- 20	836,499,987	-13	-0.0000016
100 %		- 10	836,499,988	-12	-0.0000015
100 %		0	836,499,986	-14	-0.0000017
100 %		+ 10	836,499,998	-2	-0.0000003
100 %		+ 20	836,499,982	-18	-0.0000021
100 %		+ 30	836,499,984	-16	-0.0000020
100 %		+ 40	836,499,997	-3	-0.0000003
100 %		+ 50	836,500,000	0	0.0000000
115 %	4.37	+ 20	836,499,999	-1	-0.0000001
BATT. ENDPOINT	3.40	+ 20	836,499,983	-17	-0.0000020

Table 6-11. Frequency Stability Data (Band 5)

Band 5 Frequency Stability Measurements (Cont'd)

§2.1055 §22.355 RSS-132(4.3)

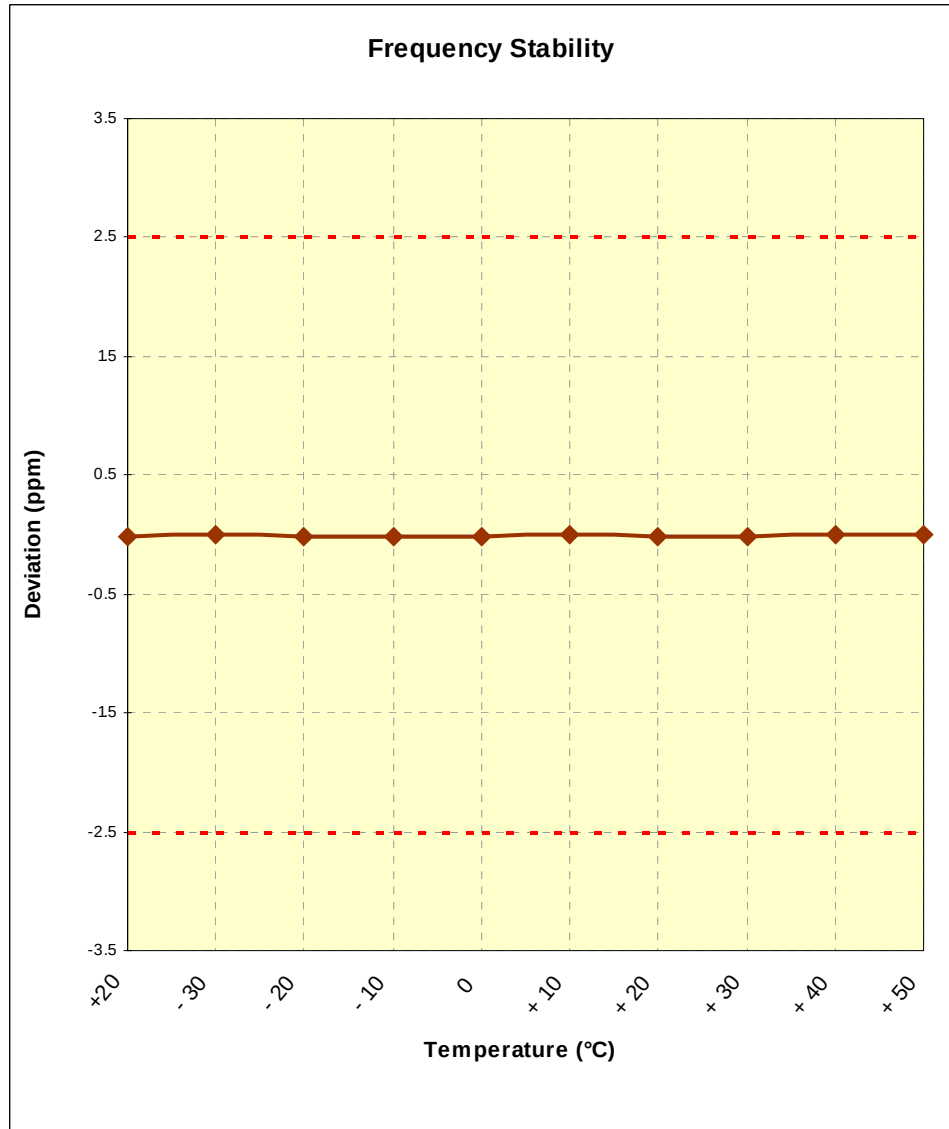
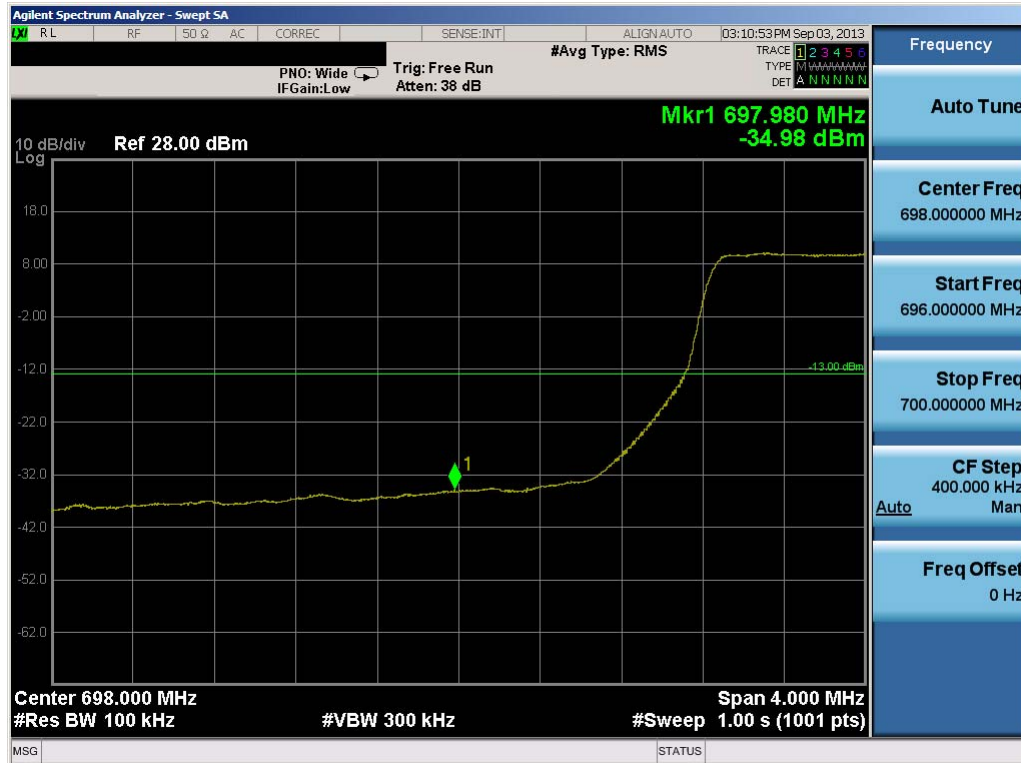


Figure 6-2. Frequency Stability Graph (Band 5)

FCC ID: A3LSCHR890		FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
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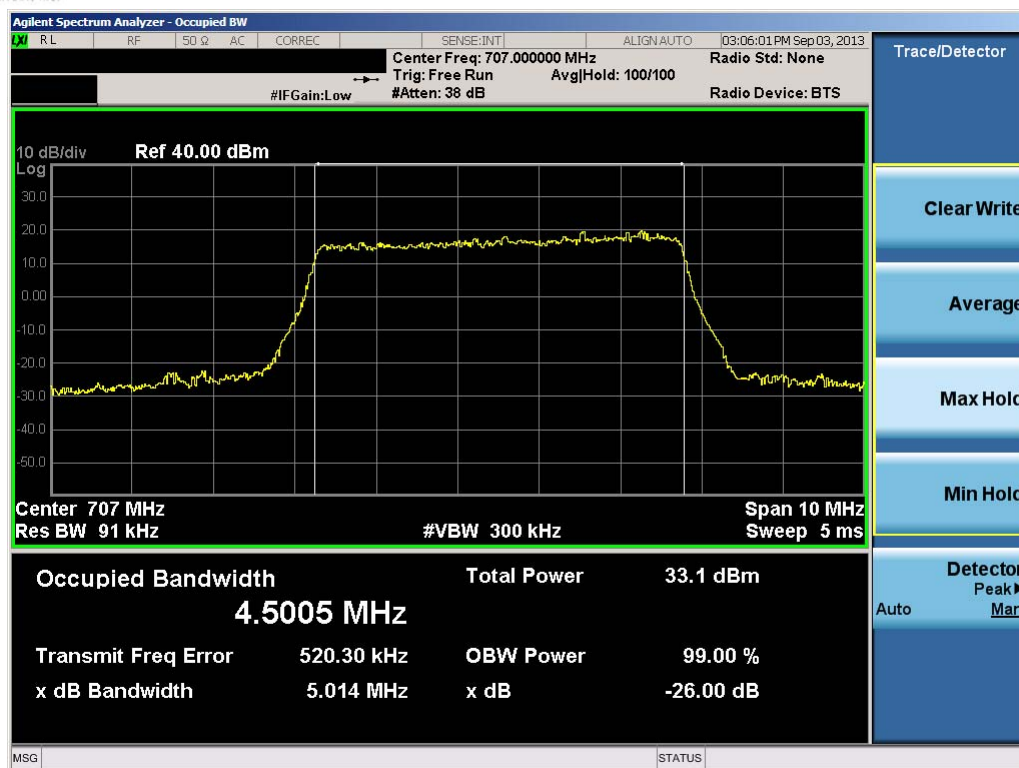
7.0 BAND 12 PLOTS OF EMISSIONS

Note: All bandwidths, RB configurations, and modulations were investigated. The worst case test results are reported below.

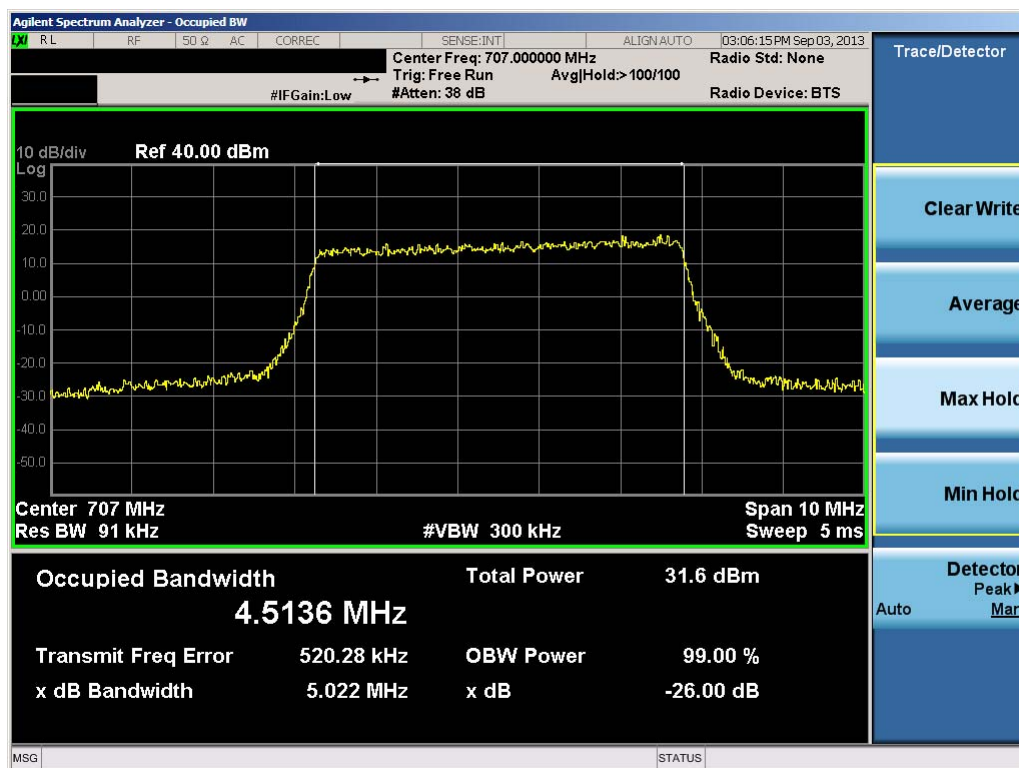


Plot 7-1. Lower Band Edge Plot (5.0MHz QPSK – RB Size 25)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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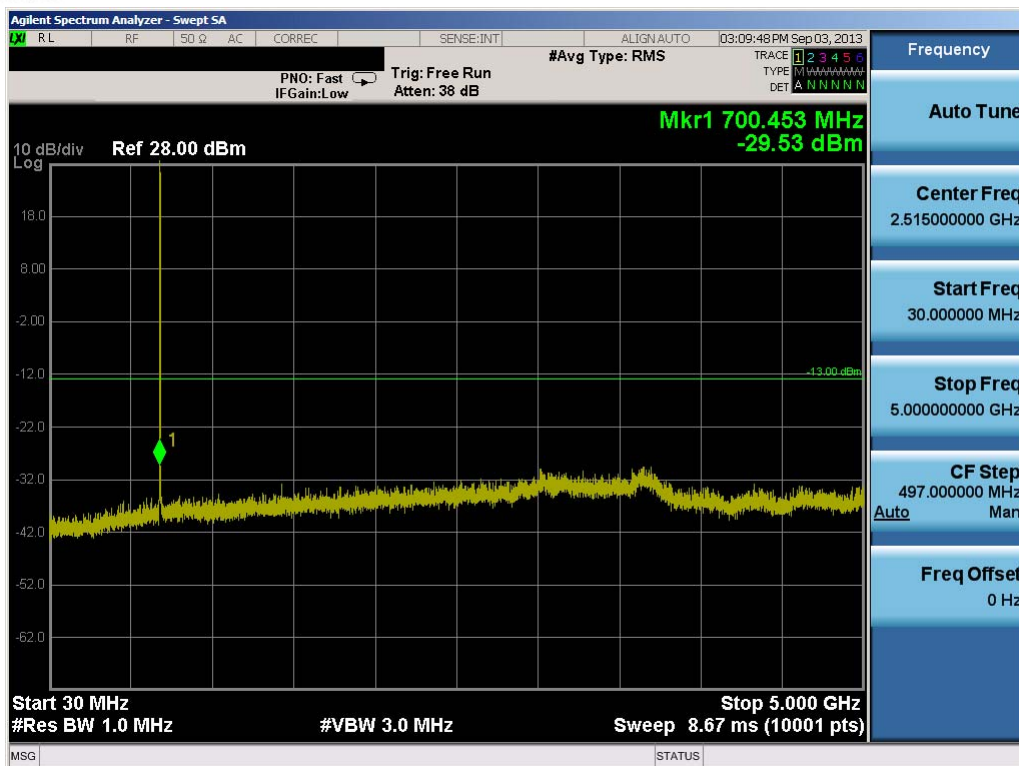


Plot 7-2. Occupied Bandwidth Plot (5.0MHz QPSK – RB Size 25)

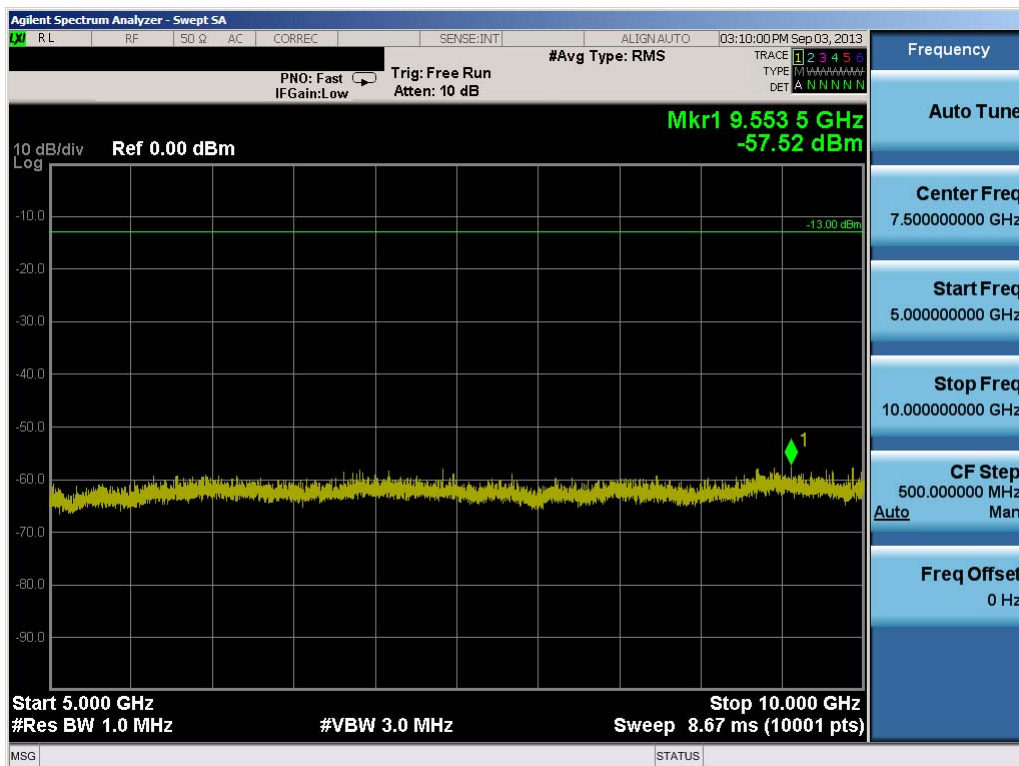


Plot 7-3. Occupied Bandwidth Plot (5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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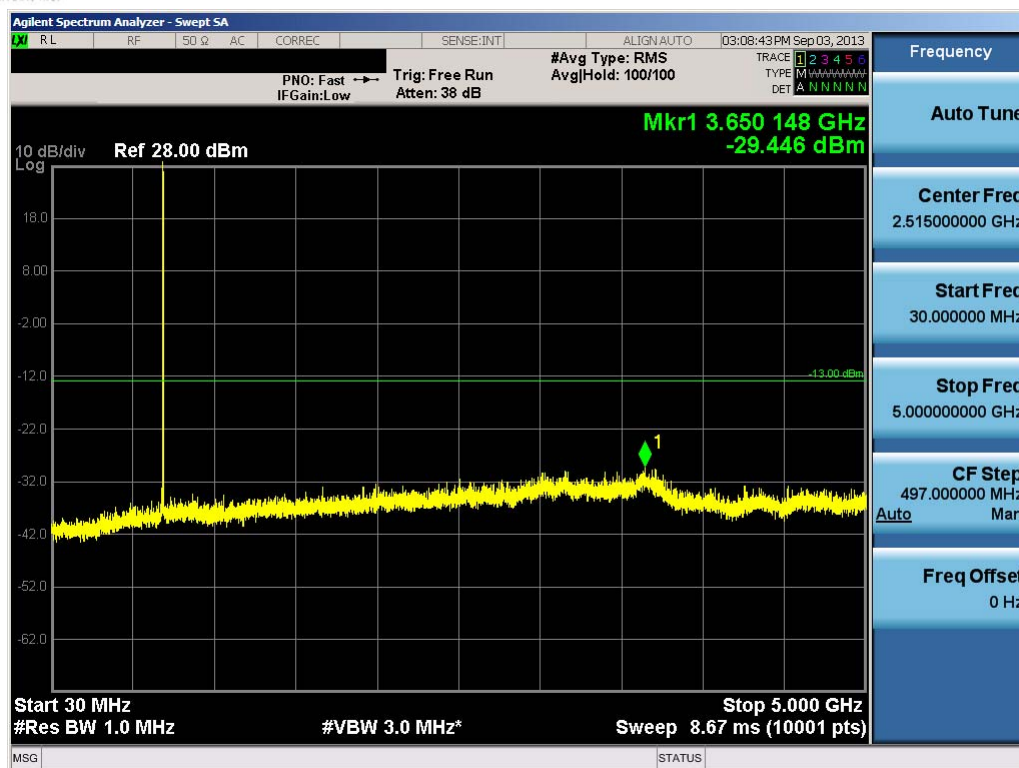


Plot 7-4. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

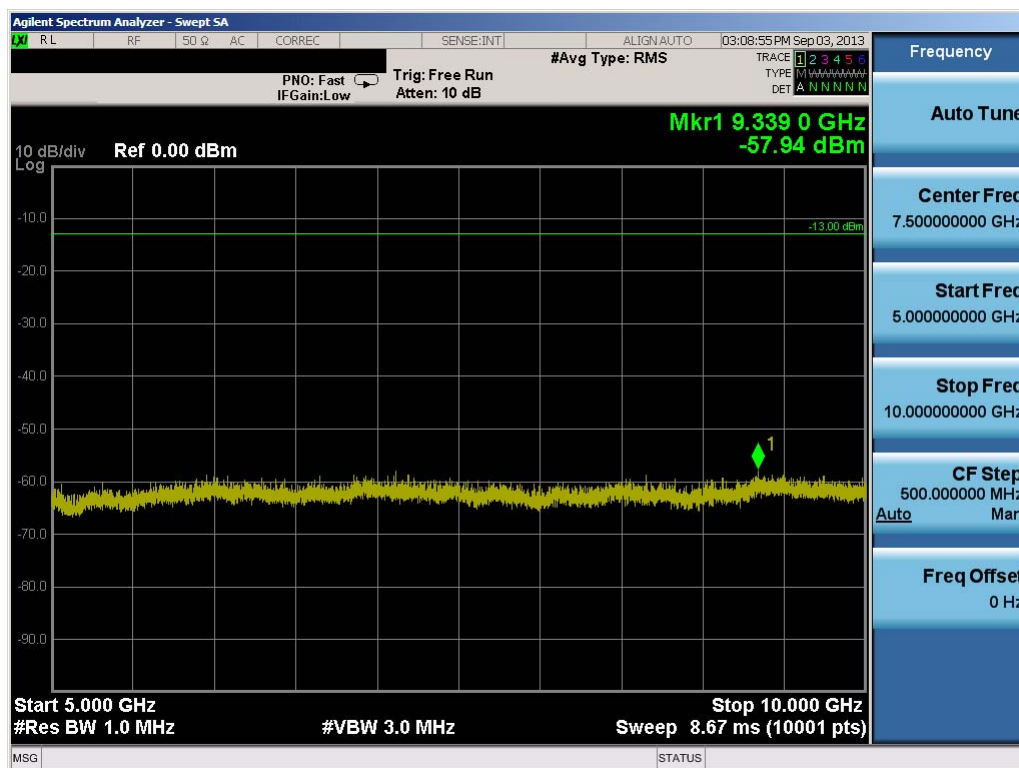


Plot 7-5. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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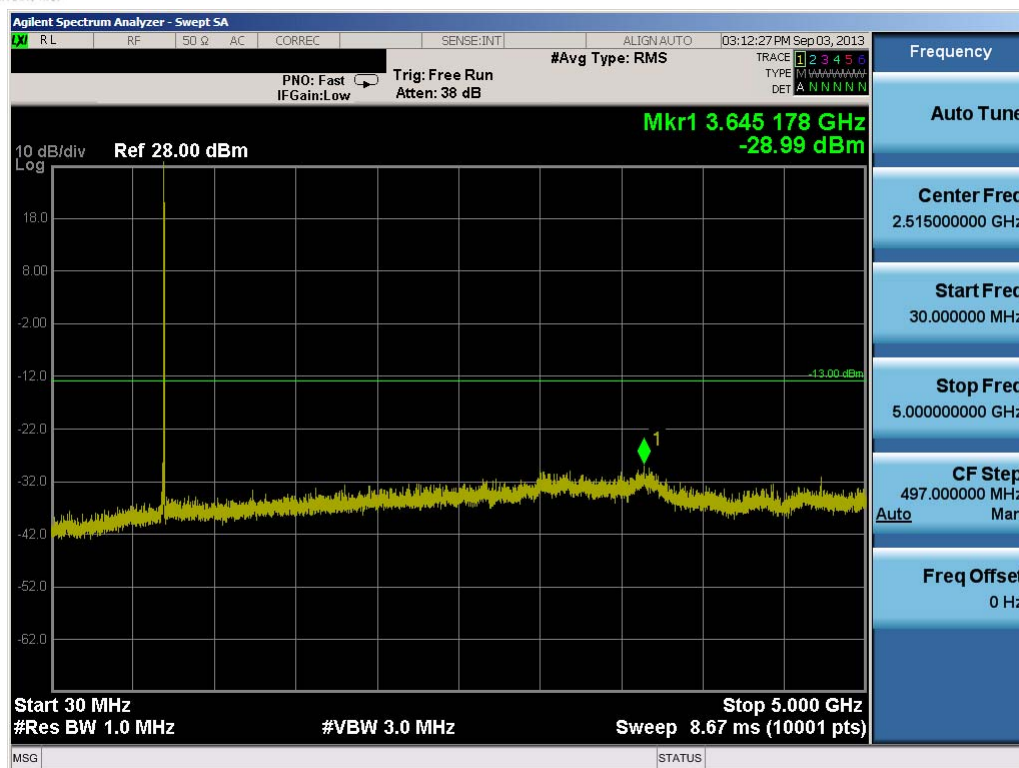


Plot 7-6. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

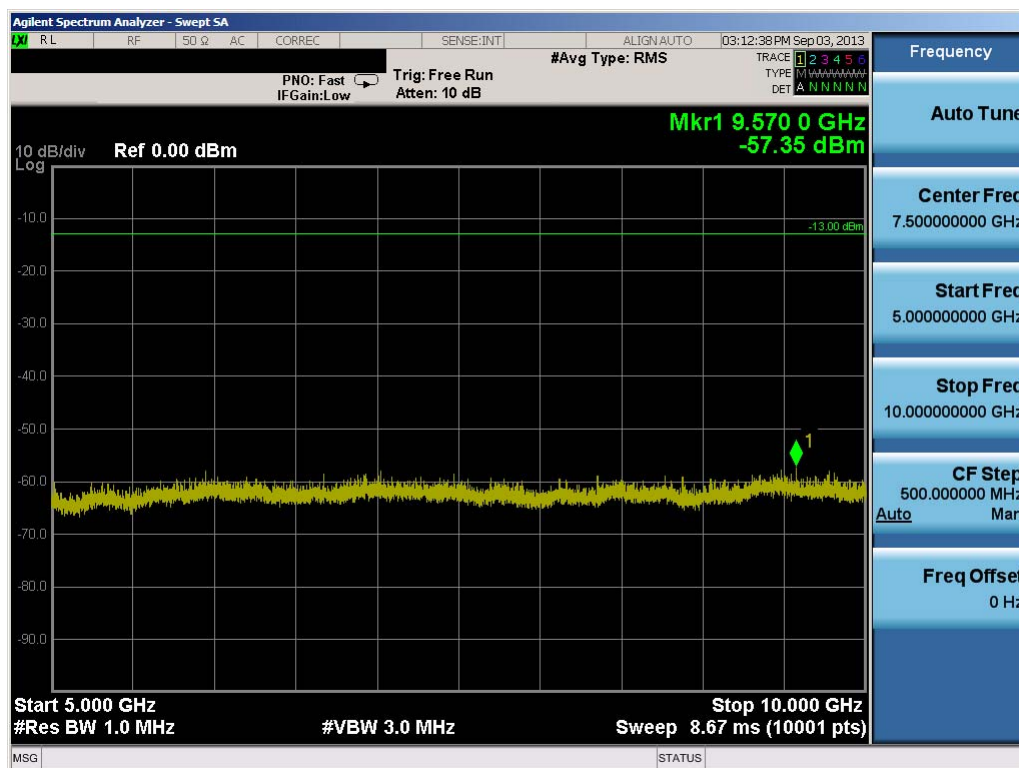


Plot 7-7. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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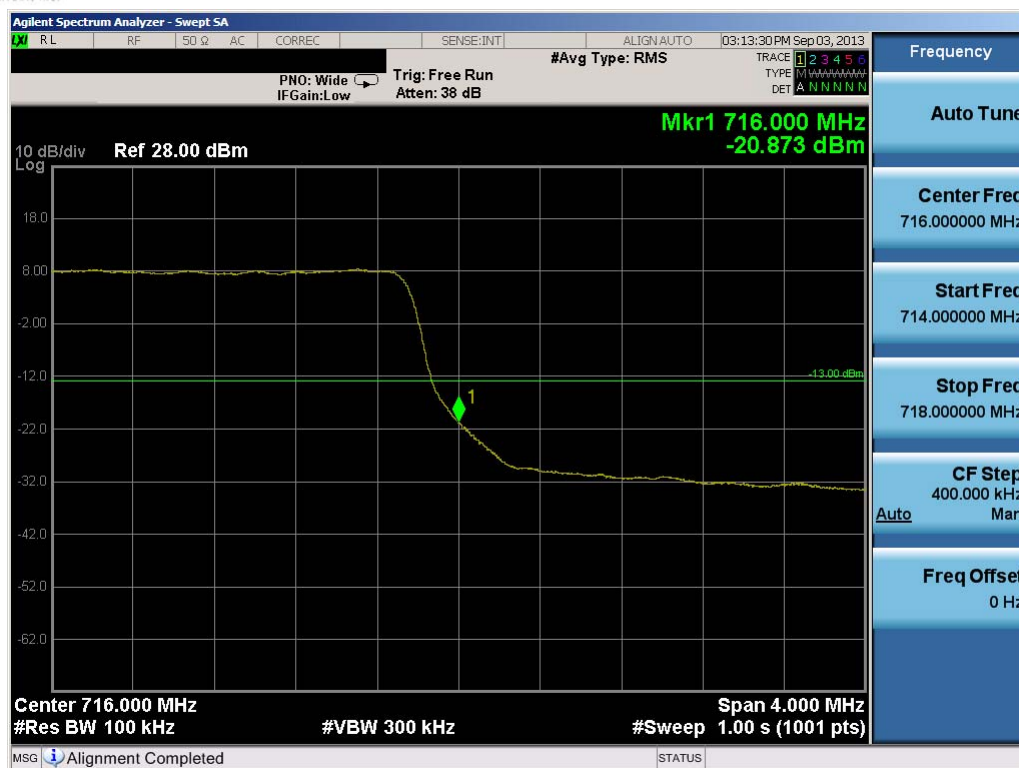


Plot 7-8. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

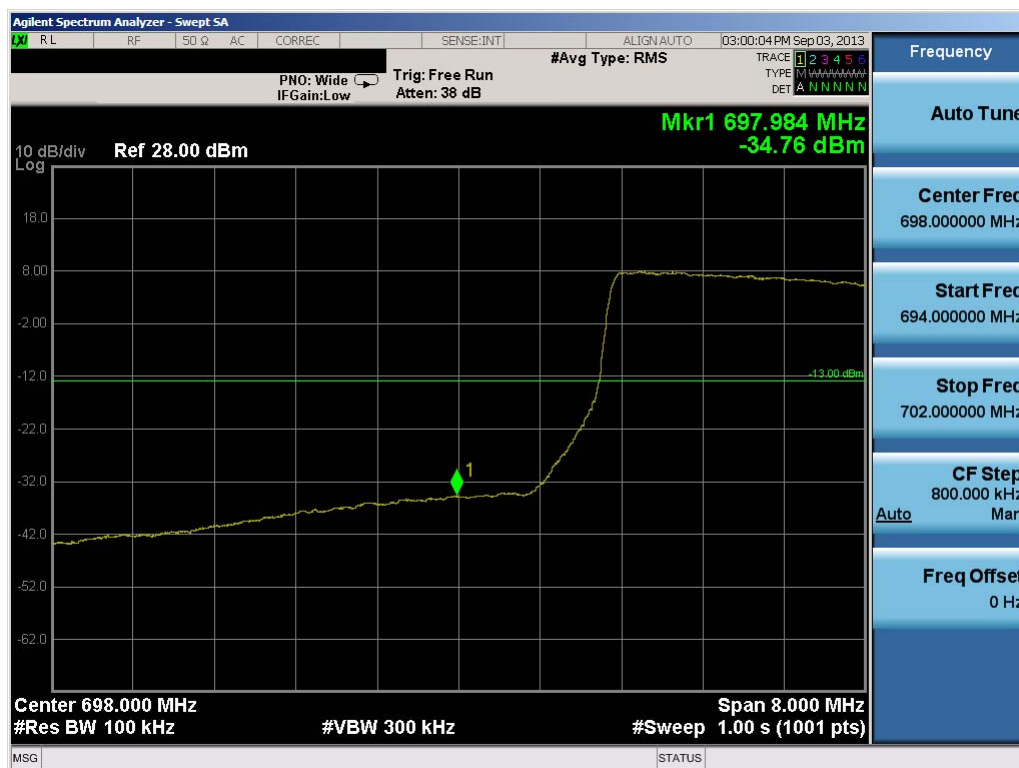


Plot 7-9. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 29 of 47

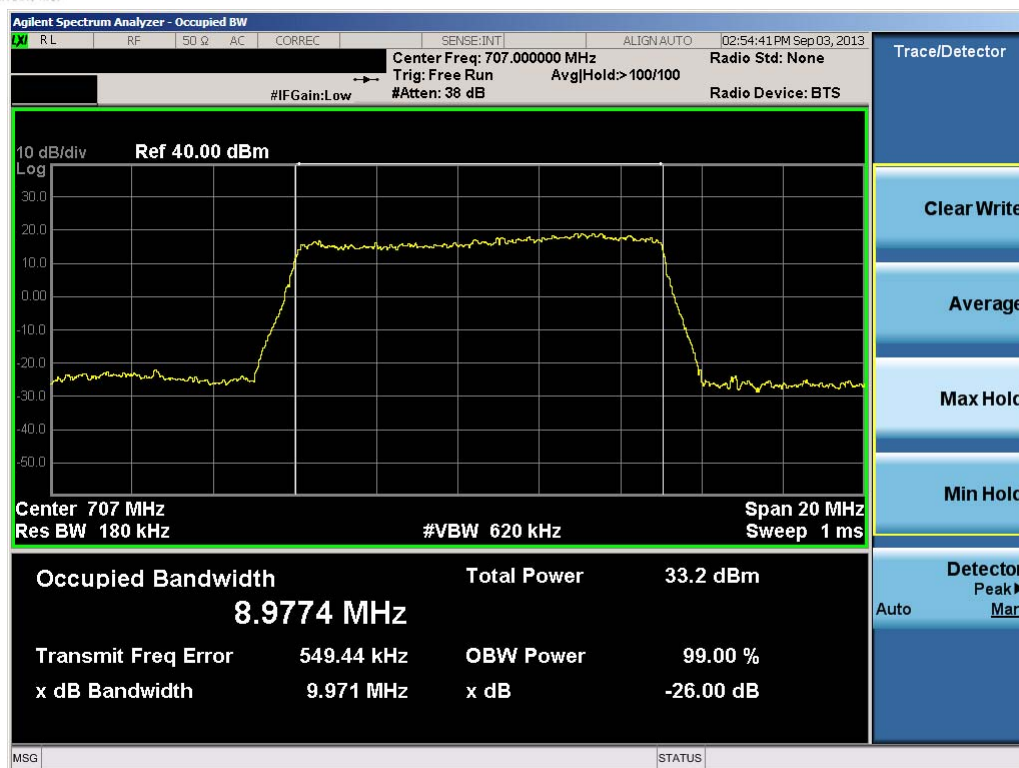


Plot 7-10. Upper Band Edge Plot (5.0MHz QPSK – RB Size 25)

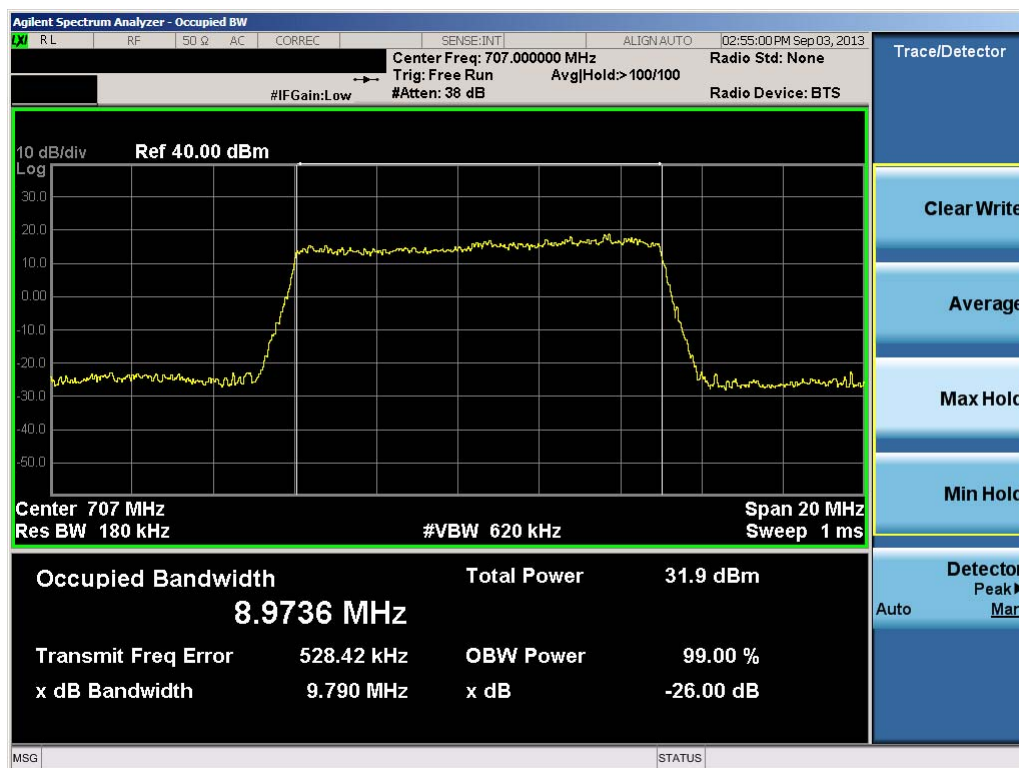


Plot 7-11. Lower Band Edge Plot (10.0MHz QPSK – RB Size 50)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 30 of 47

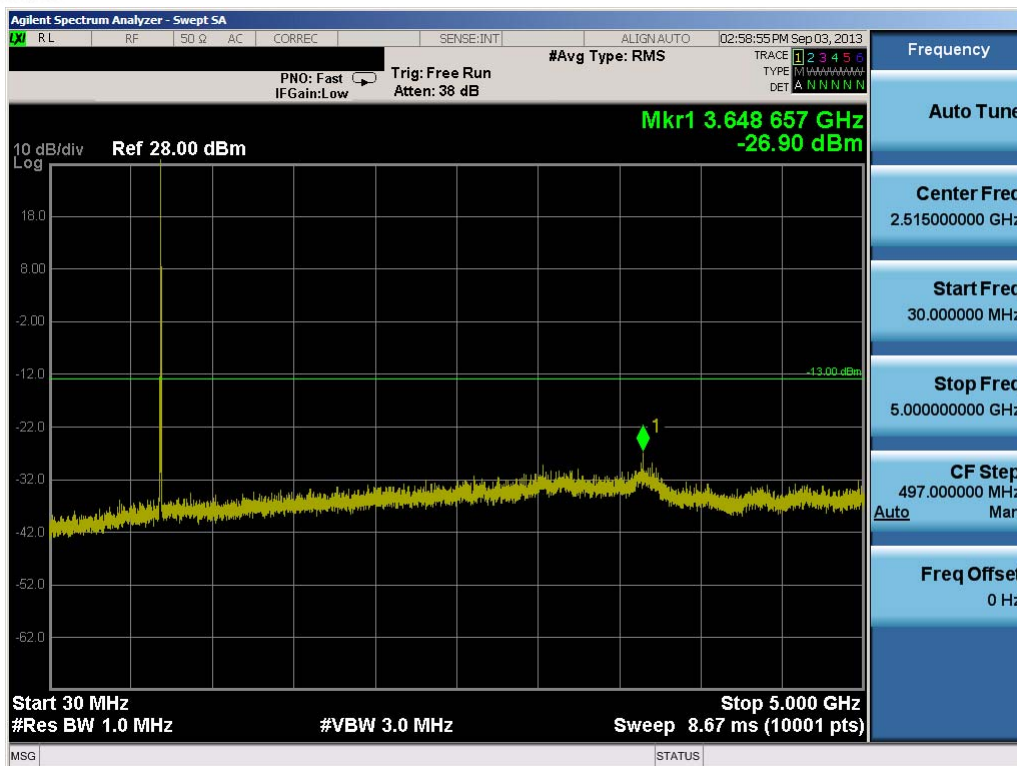


Plot 7-12. Occupied Bandwidth Plot (10.0MHz QPSK – RB Size 50)

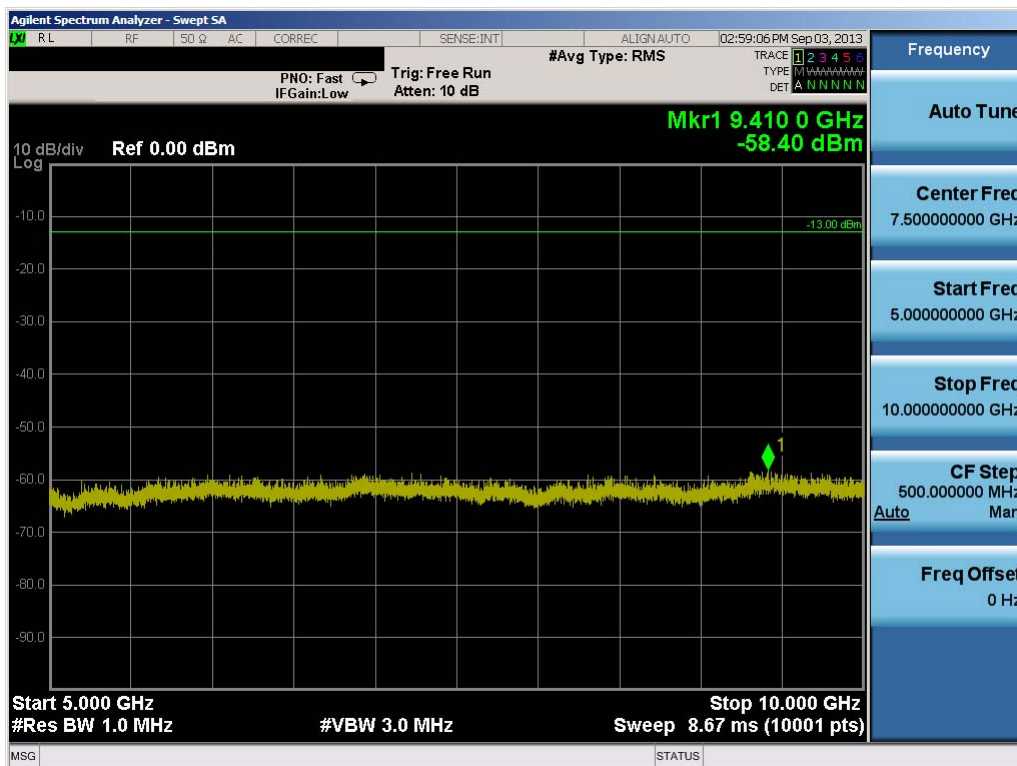


Plot 7-13. Occupied Bandwidth Plot (10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset	Page 31 of 47

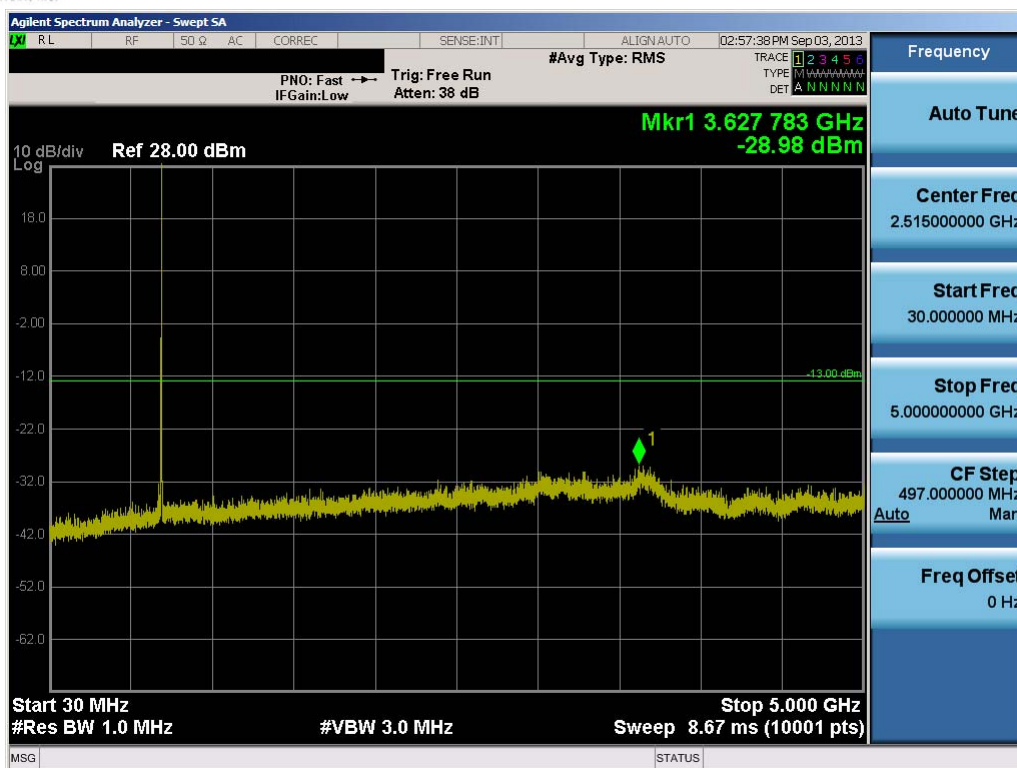


Plot 7-14. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0– Low Channel)

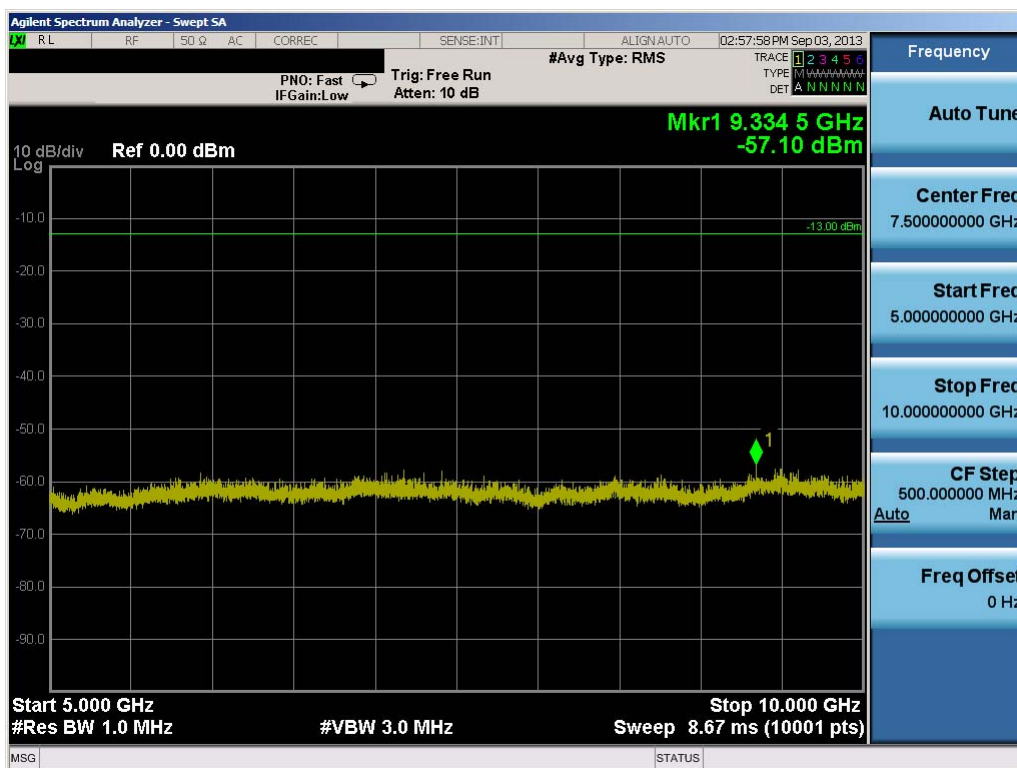


Plot 7-15. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 32 of 47

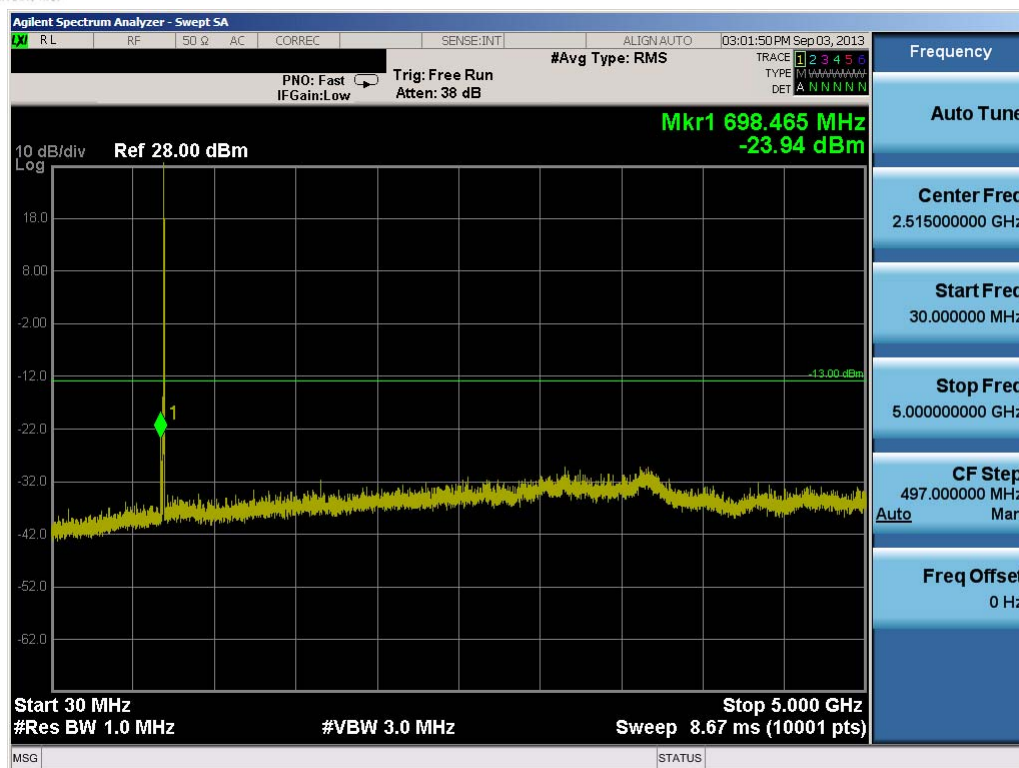


Plot 7-16. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

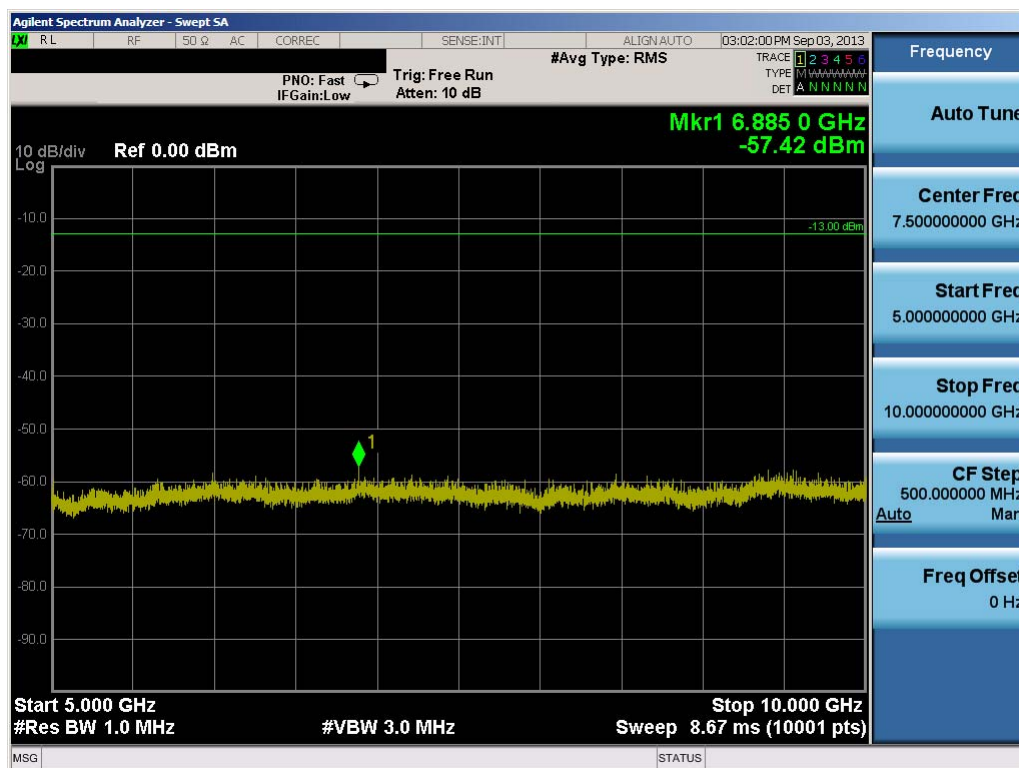


Plot 7-17. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 33 of 47



Plot 7-18. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)



Plot 7-19. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 34 of 47

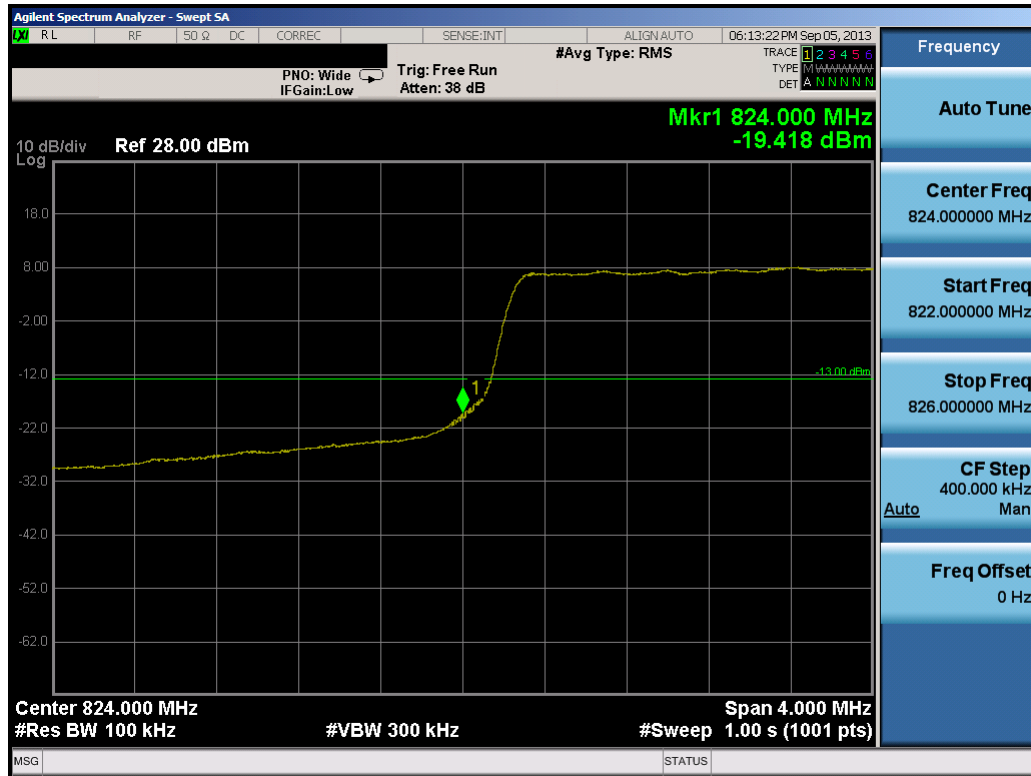


Plot 7-20. Upper Band Edge Plot (10.0MHz QPSK – RB Size 50)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 35 of 47

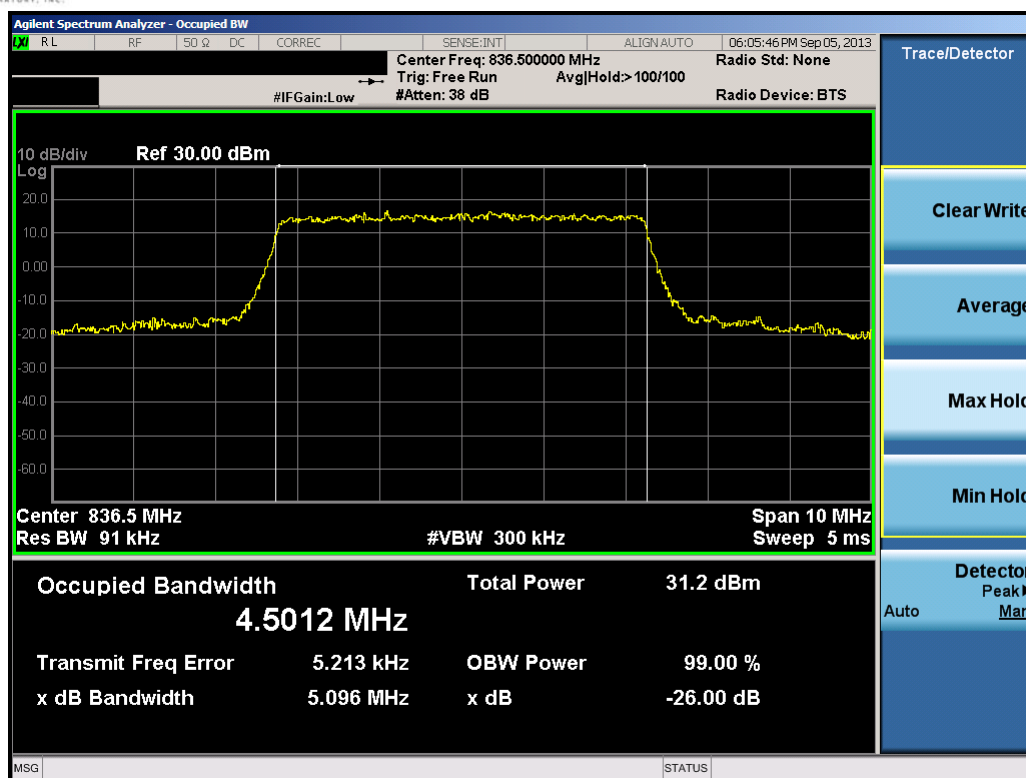
8.0 BAND 5 PLOTS OF EMISSIONS

Note: All bandwidths, RB configurations, and modulations were investigated. The worst case test results are reported below.

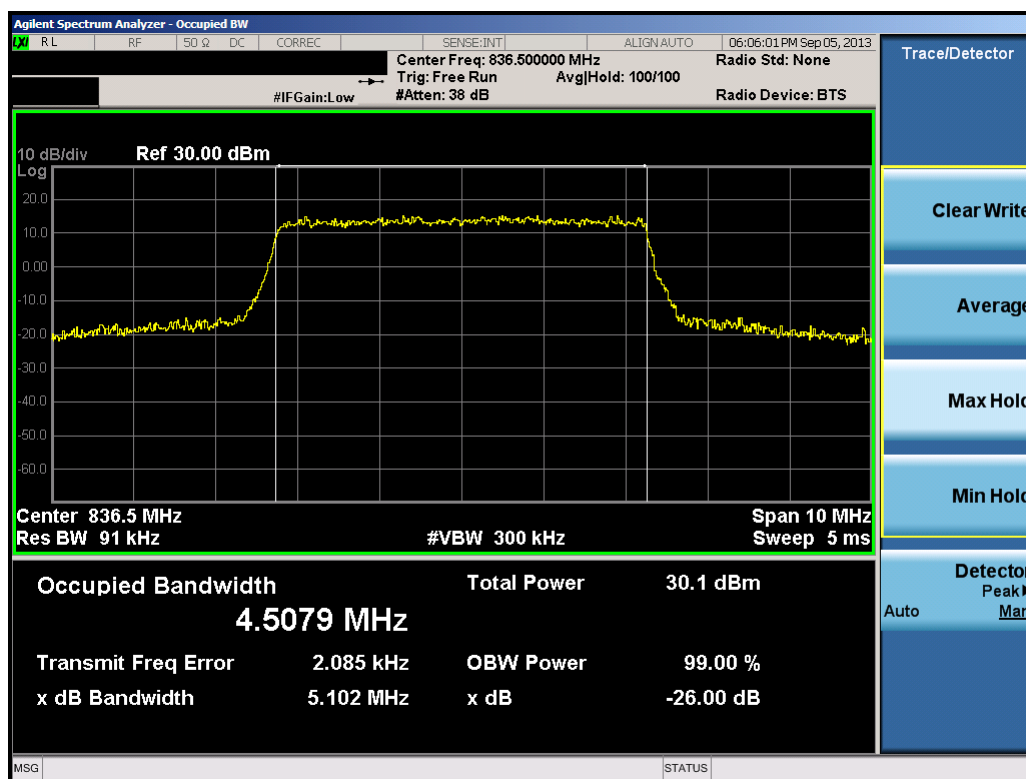


Plot 8-1. Lower Band Edge Plot (5.0MHz QPSK – RB Size 25)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 36 of 47

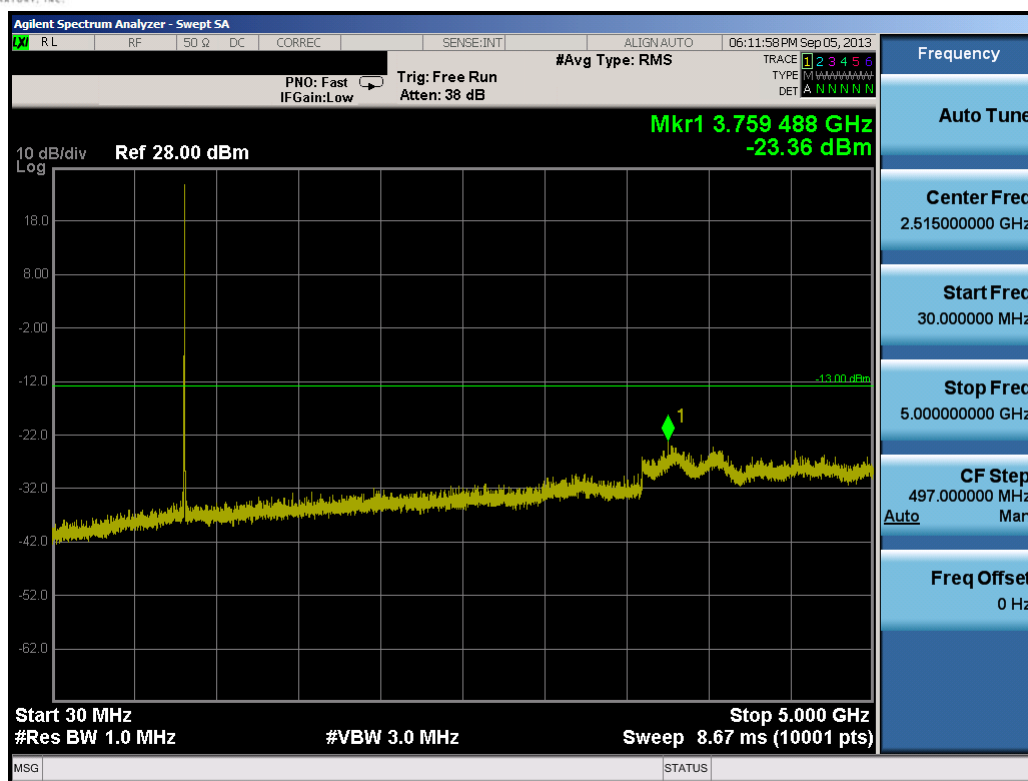


Plot 8-2. Occupied Bandwidth Plot (5.0MHz QPSK – RB Size 25)

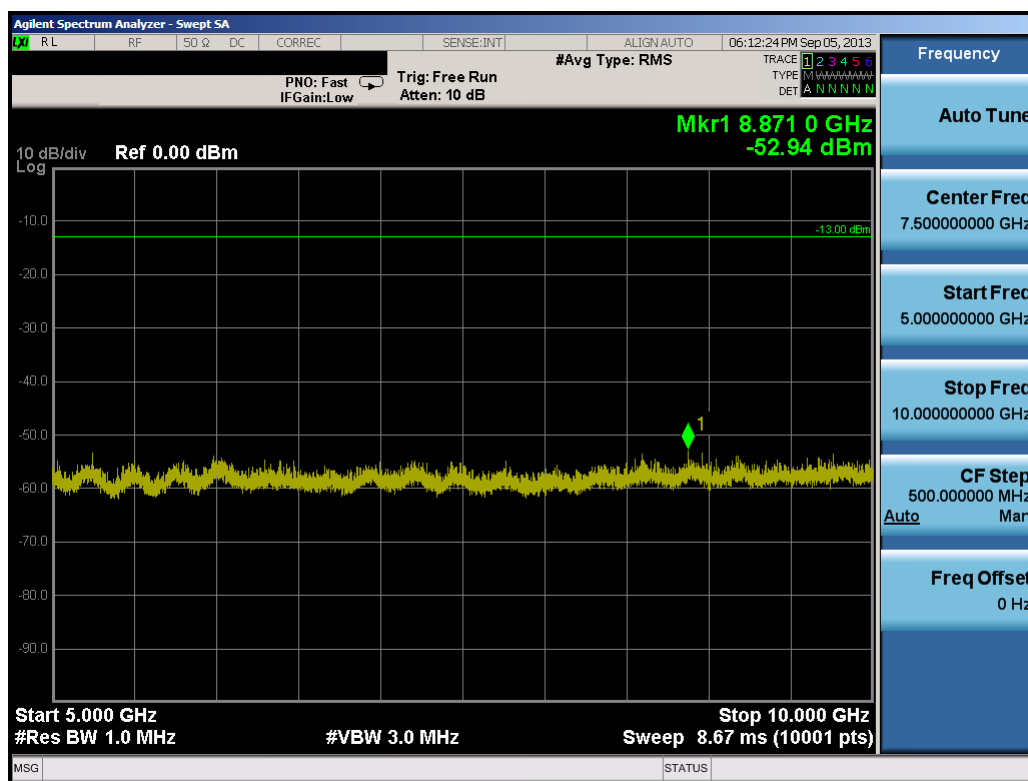


Plot 8-3. Occupied Bandwidth Plot (5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 37 of 47

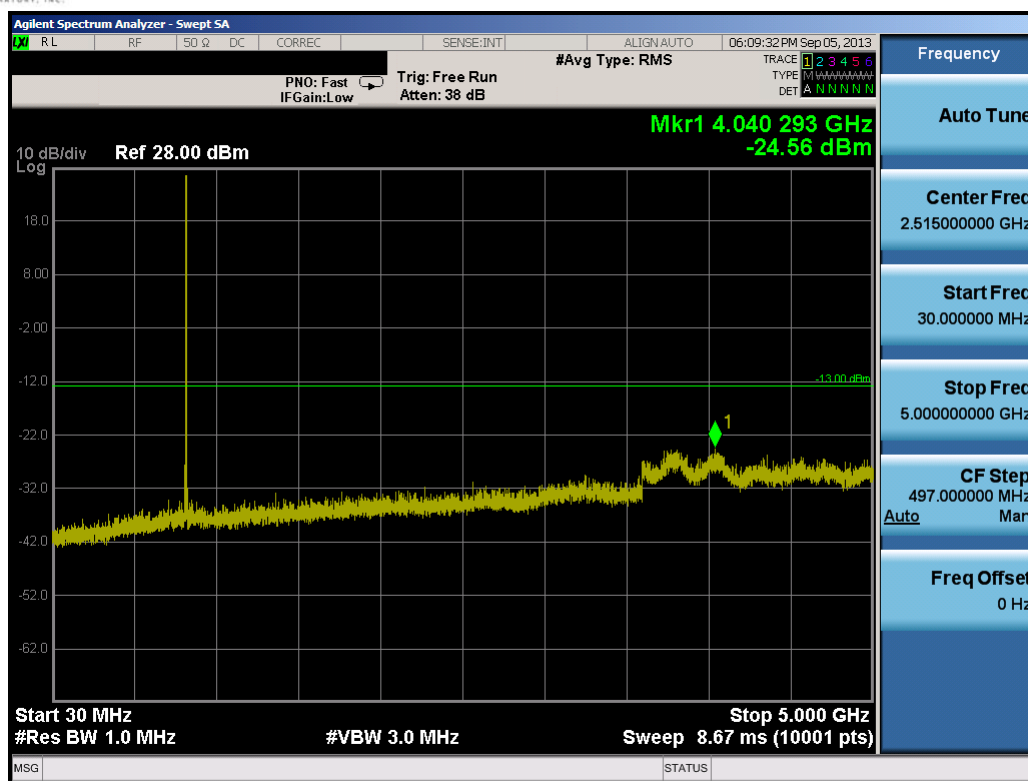


Plot 8-4. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

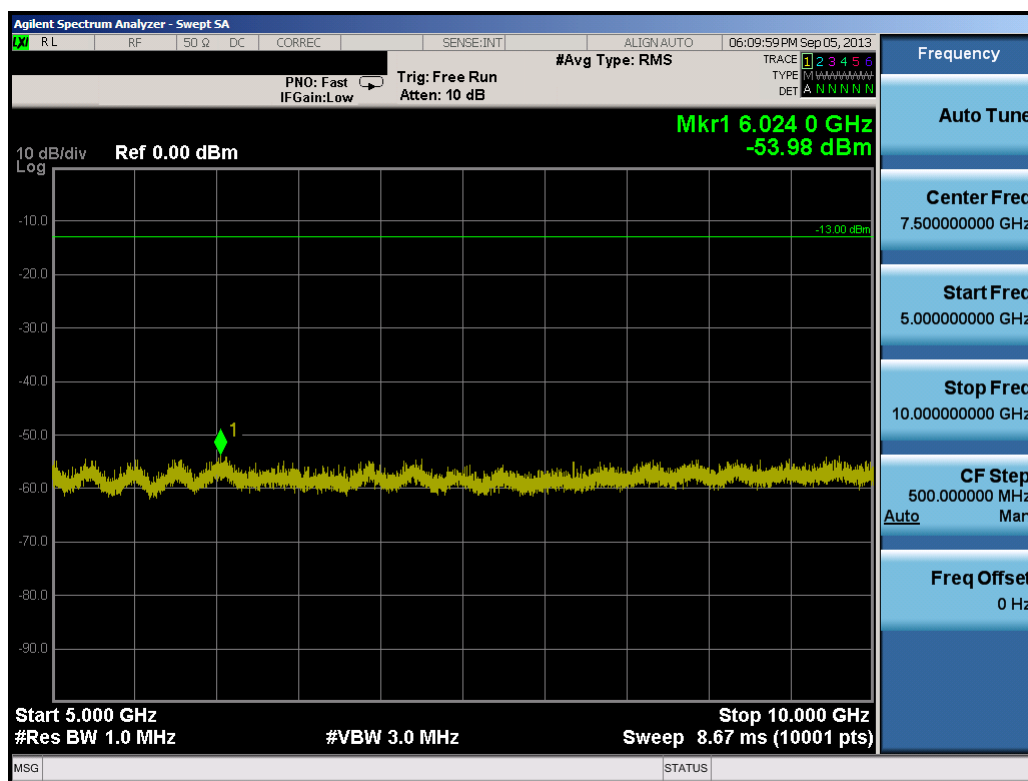


Plot 8-5. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 38 of 47

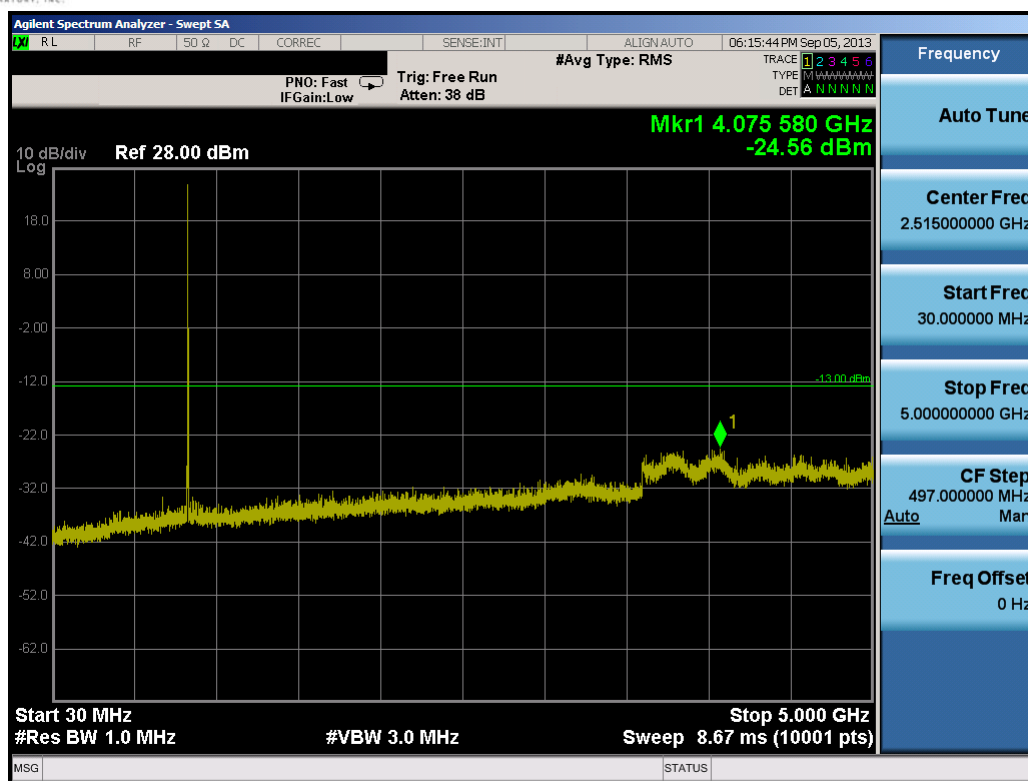


Plot 8-6. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

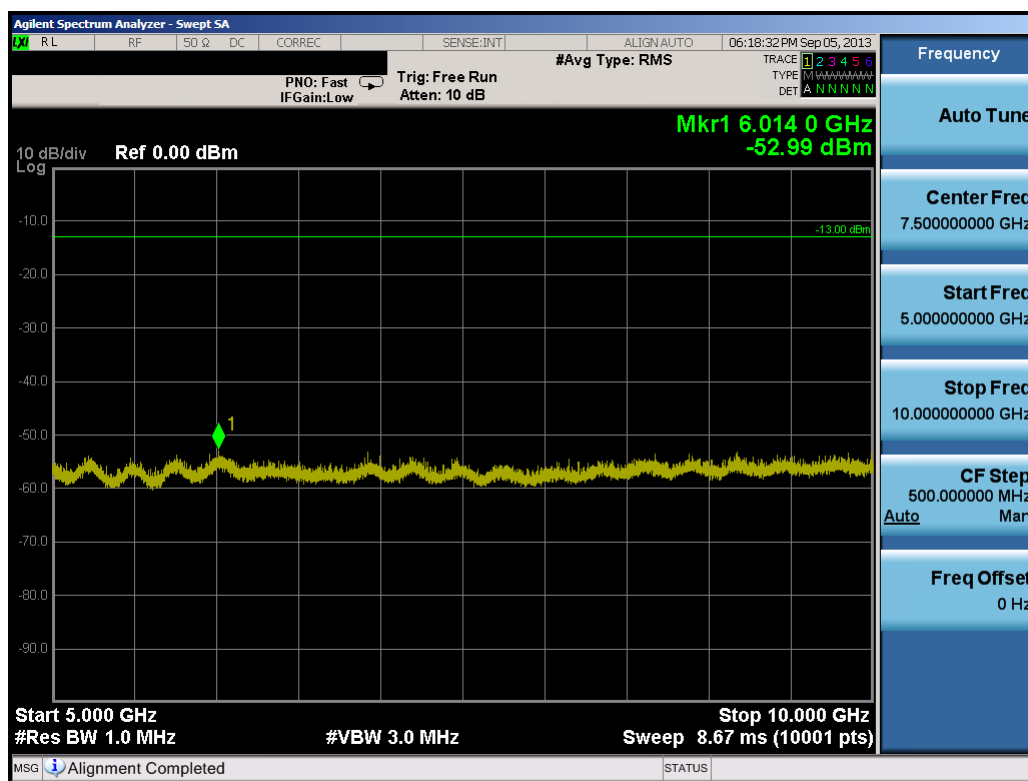


Plot 8-7. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 39 of 47

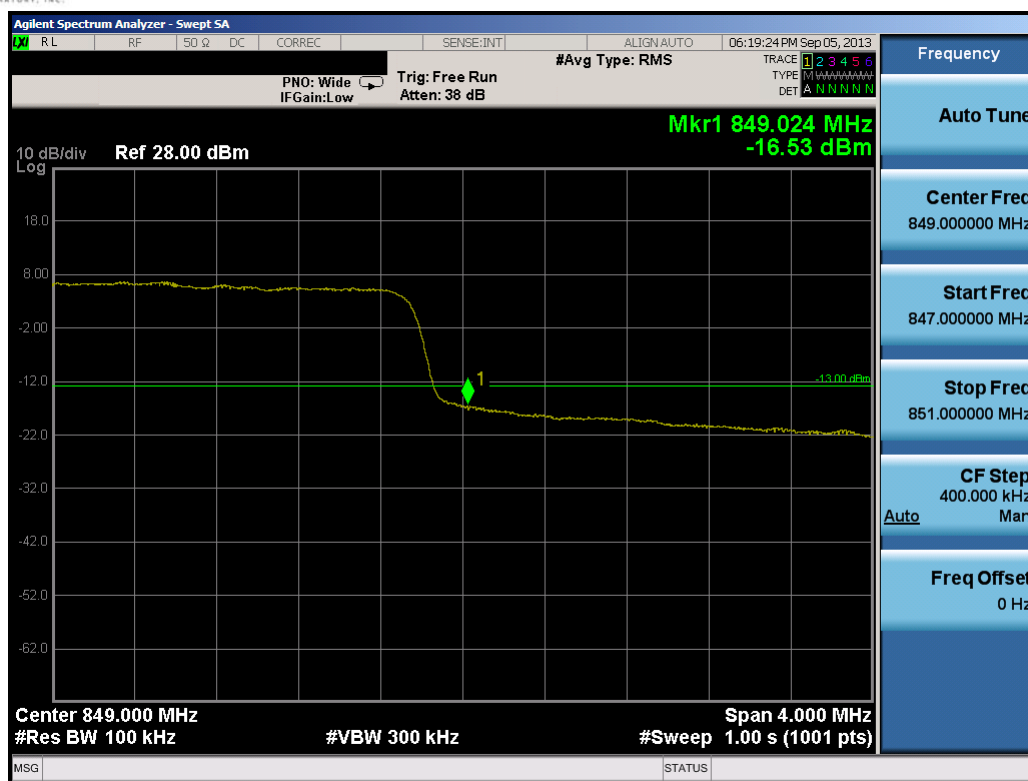


Plot 8-8. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

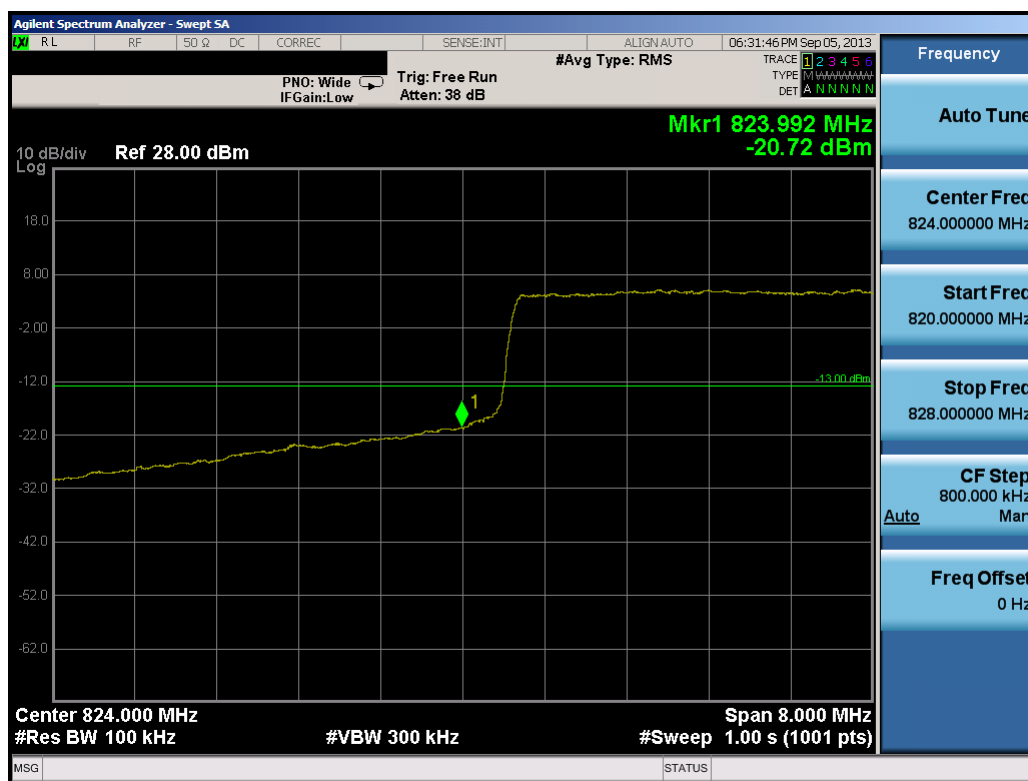


Plot 8-9. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 40 of 47

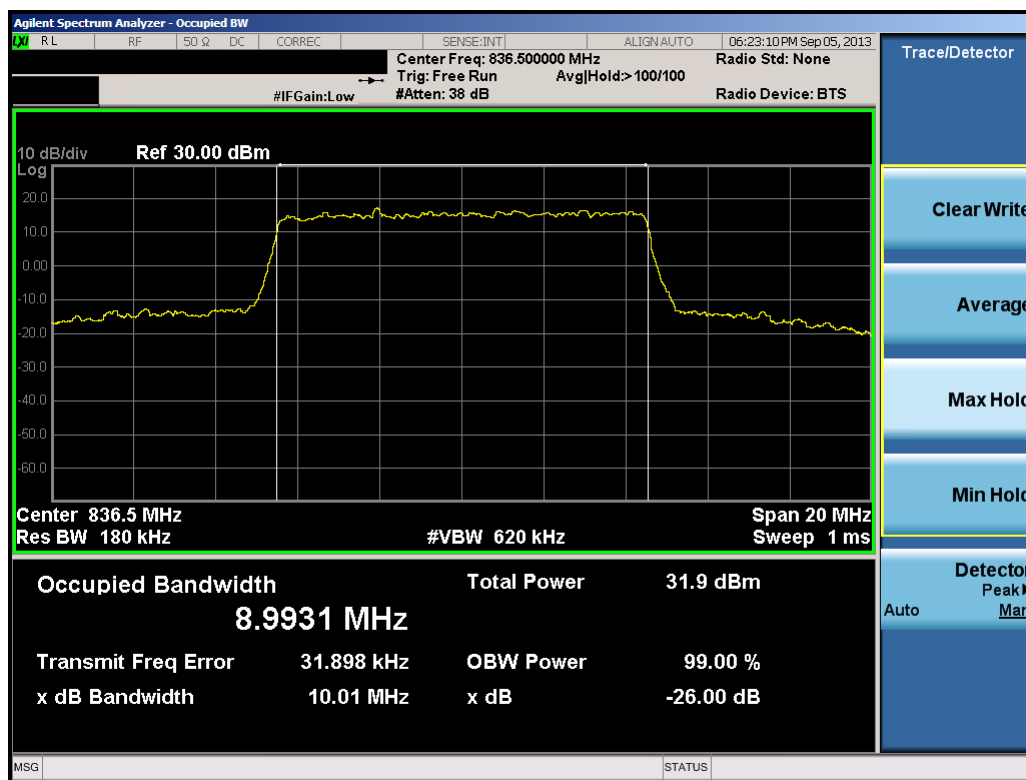


Plot 8-10. Upper Band Edge Plot (5.0MHz QPSK – RB Size 25)

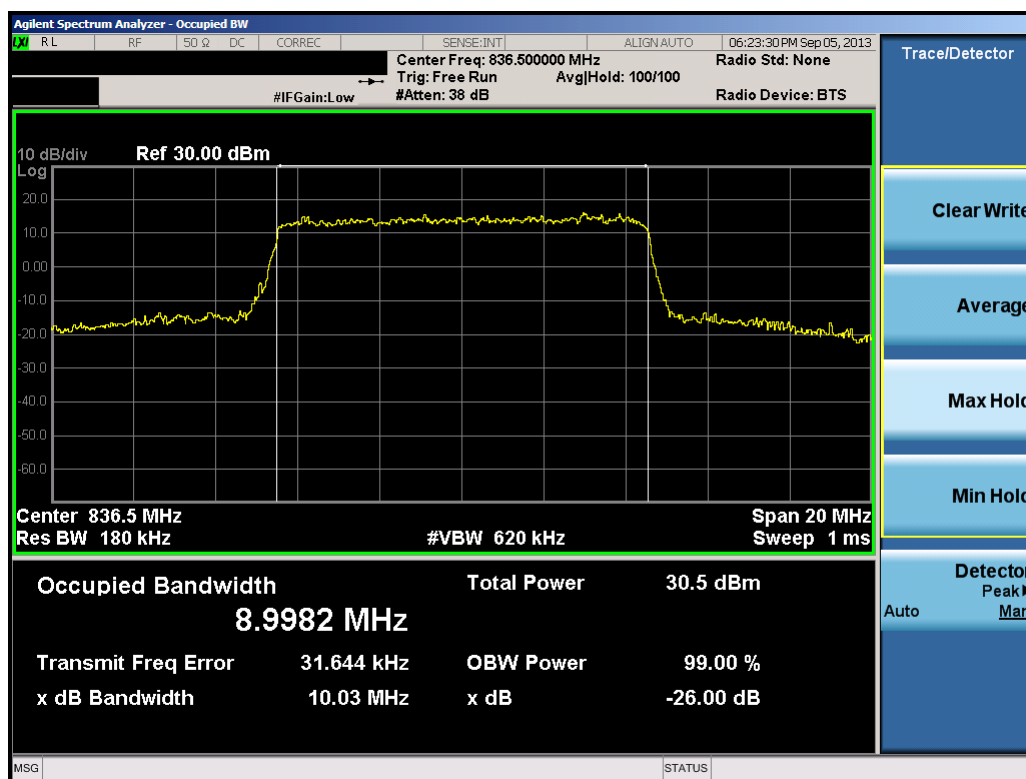


Plot 8-11. Lower Band Edge Plot (10.0MHz QPSK – RB Size 50)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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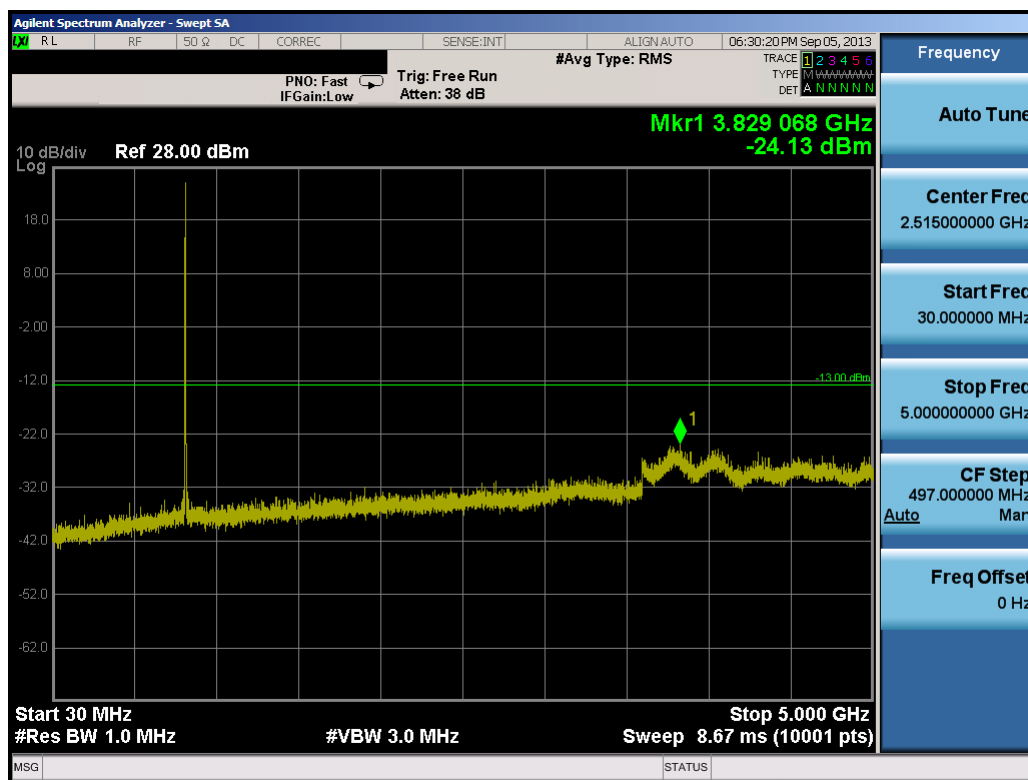


Plot 8-12. Occupied Bandwidth Plot (10.0MHz QPSK – RB Size 50)

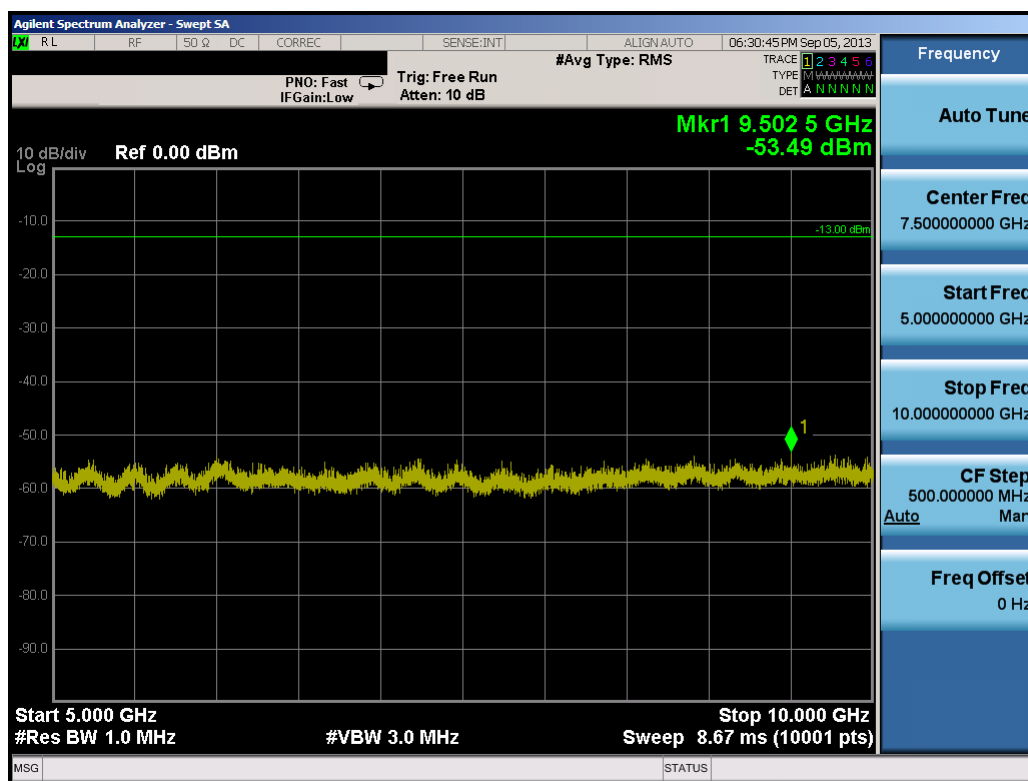


Plot 8-13. Occupied Bandwidth Plot (10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset	Page 42 of 47

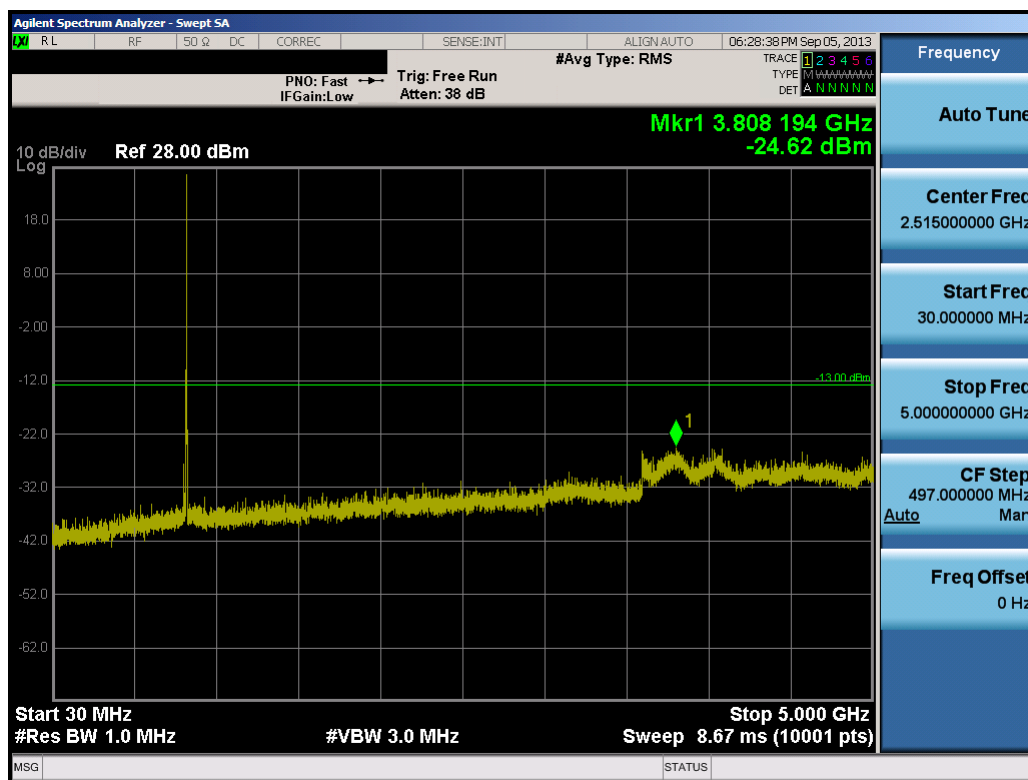


Plot 8-14. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0– Low Channel)

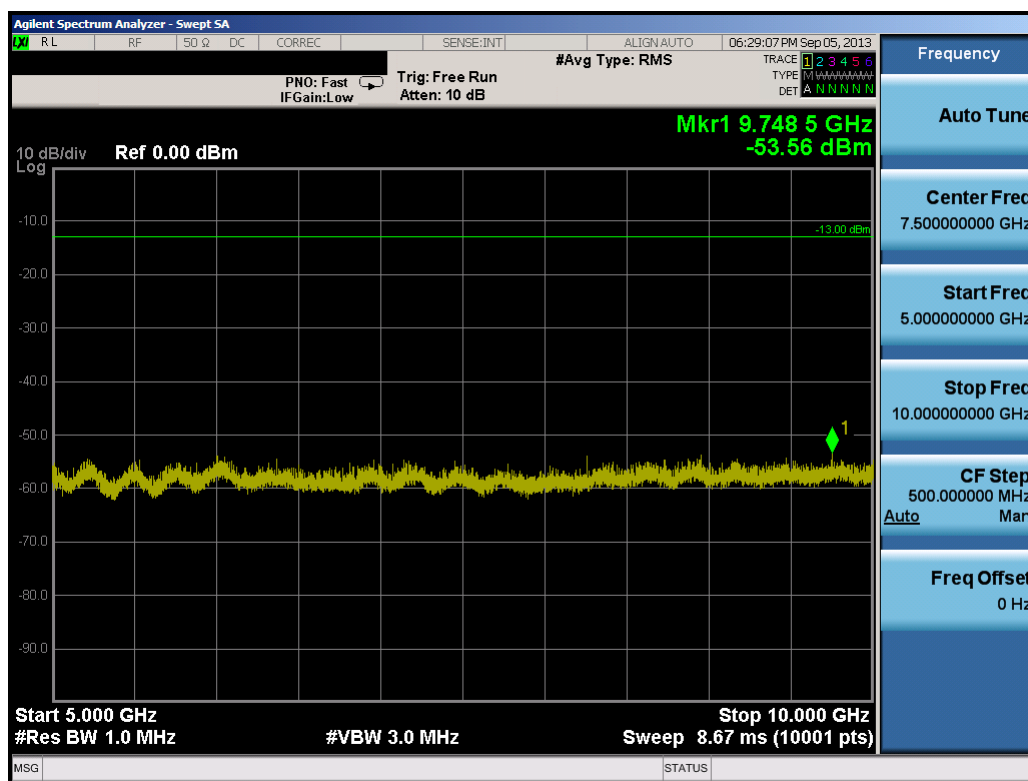


Plot 8-15. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 43 of 47

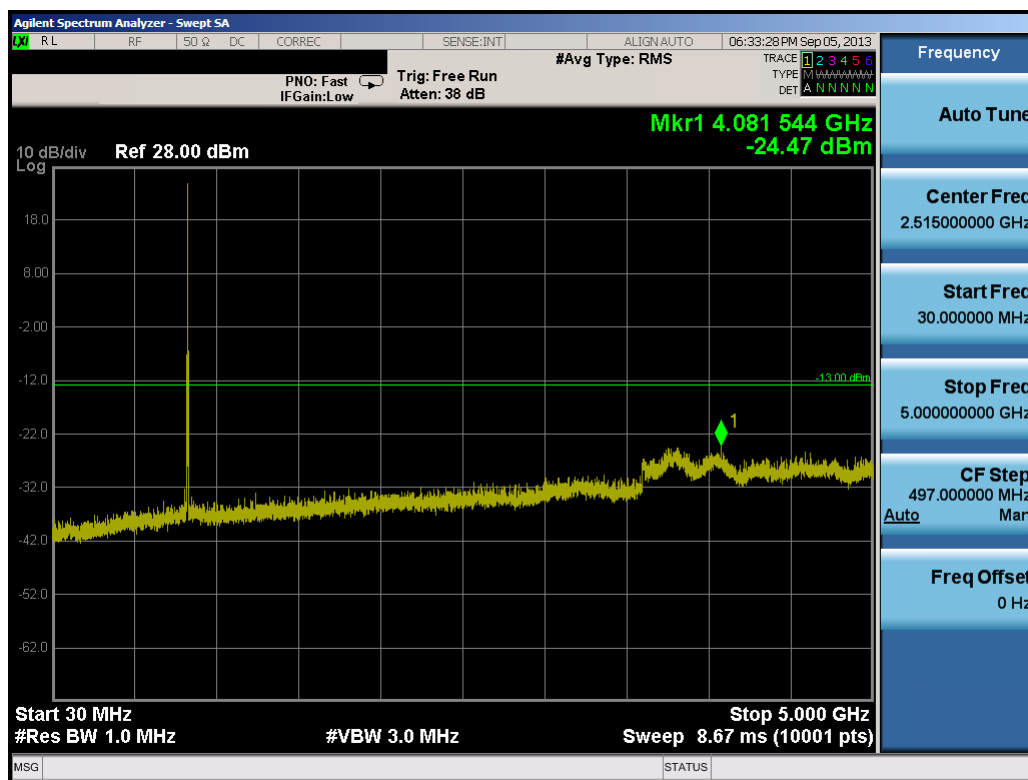


Plot 8-16. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

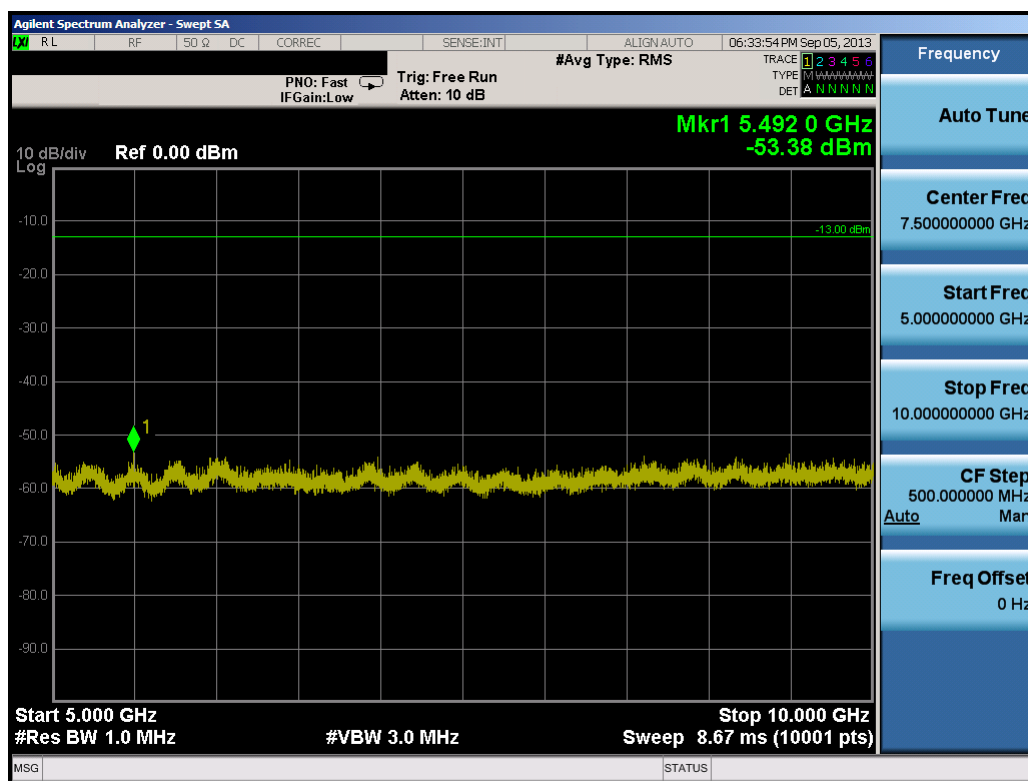


Plot 8-17. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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Plot 8-18. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)



Plot 8-19. Conducted Spurious Plot (10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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Plot 8-20. Upper Band Edge Plot (10.0MHz QPSK – RB Size 50)

FCC ID: A3LSCHR890	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Reviewed by: Quality Manager
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9.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSCHR890** complies with all the requirements of Parts 2, 22, 27 of the FCC rules for LTE operation only.

FCC ID: A3LSCHR890		FCC Pt. 22 & 27 LTE MEASUREMENT REPORT (CERTIFICATION)		Reviewed by: Quality Manager
Test Report S/N: 0Y1308271675.A3L	Test Dates: Aug. 31 - Sep. 5, 2013	EUT Type: Portable Handset		Page 47 of 47